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A Powerful Tuning Parameter Free Test of the Autoregressive Unit Root Hypothesis

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Abstract

This paper presents a family of simple nonparametric unit root tests indexed by one parameter, d, and containing Breitung's (2002) test as the special case d = 1. It is shown that (i) each member of the family with d > 0 is consistent, (ii) the asymptotic distribution depends on d, and thus reflects the parameter chosen to implement the test, and (iii) since the asymptotic distribution depends on d and the test remains consistent for all d > 0, it is possible to analyze the power of the test for different values of d. The usual Phillips-Perron or Dickey-Fuller type tests are characterized by tuning parameters (bandwidth, lag length, etc.), i.e. parameters which change the test statistic but are not reflected in the asymptotic distribution, and thus have none of these three properties.

It is shown that members of the family with d < 1 have higher asymptotic local power than the Breitung (2002) test, and when d is small the asymptotic local power of the proposed nonparametric test is relatively close to the parametric power envelope, particularly in the case with a linear timetrend. Furthermore, GLS detrending is shown to improve power when d is small, which is not the case for Breitung's (2002) test. Simulations demonstrate that, apart from some size distortion in the presence of large negative AR or MA coefficients, the proposed test has good finite sample properties in the presence of both linear and nonlinear short-run dynamics. When applying a sieve bootstrap procedure, the proposed test has very good size properties, with finite sample power that is higher than that of Breitung's (2002) test and even rivals the (nearly) optimal parametric GLS detrended augmented Dickey-Fuller test with lag length chosen by an information criterion.

JEL Classification: C22.

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Short Title: Tuning Parameter Free Unit Root Test.

1 Introduction

The problem of testing for an autoregressive unit root is one of the most intensely studied testing problems in time series econometrics over the last three decades; seminal contributions to this literature include Dickey & Fuller (1979, 1981), Phillips (1987*a*), Phillips & Perron (1988), and Elliott, Rothenberg & Stock (1996). For general reviews see, e.g., Stock (1994) or Phillips & Xiao (1998). Remarkably, research on testing for unit roots has been characterized by parallel developments in theoretical and empirical econometrics, and the relevance and importance of this problem to empirical research is undeniable.

Recently, important progress has been made towards constructing unit root tests with better size and power properties. Examples include the point optimal tests and augmented Dickey-Fuller (ADF) tests with GLS detrending of Elliott et al. (1996), and the use of improved data dependent lag selection information criteria as in Ng & Perron (2001) and Perron & Qu (2007). See Haldrup & Jansson (2006) for a review focusing on power properties. The seminal contribution of Elliott et al. (1996) developed a theory of optimal testing in the framework of unit root tests, leading to the construction of power envelopes for such tests, i.e. bounds on the possible power of parametric unit root tests under conditions allowing for serial correlation, deterministic components, etc.

Nevertheless, all these tests share similar shortcomings. In particular, in the presence of serial correlation nuisance parameters appear in the asymptotic distribution unless the tests are modified to cope with the serial correlation. The ADF type tests, including the ADF-GLS tests of Elliott et al. (1996), are parametric and require selection of a lag length for the augmentation to handle serial correlation. Similarly, the Phillips-Perron tests of Phillips (1987a) and Phillips & Perron (1988), although handling the serial correlation by a nonparametric correction, require selection of bandwidth and kernel for the estimation of the long-run variance. The performance of the tests depend highly on the choice of lag length or bandwidth parameters, both in terms of finite sample power and size properties (although data dependent lag selection information criteria improve the tests in this respect, see Ng & Perron (2001)), but also asymptotically since the consistency of the tests requires that the lag length or bandwidth parameters expand at particular rates relative to the sample size.¹ Furthermore, the asymptotic distributions of these test statistics are independent of the lag length, bandwidth, or kernel employed to construct the tests, and thus do not reflect the particular choice of these parameters. That is, the tests are characterized by parameters (lag length, bandwidth, etc.) which change the value of the test statistics but are not reflected in the corresponding asymptotic distributions, and hence, in particular, not reflected in the critical values for the test statistics – such parameters are referred to as *tuning parameters*.

¹For example, Agiakloglou & Newbold (1996) study the trade-off between size and power in Dickey-Fuller tests when data-dependent rules are used for the choice of lag order, and Leybourne & Newbold (1999b, 1999b) examine the behavior (e.g. with respect to the nuisance parameter issue) of both Dickey-Fuller and Phillips-Perron tests.

Existing unit root tests that are free of tuning parameters include the variable addition test of Park & Choi (1988), see also Park (1990), and the nonparametric test of Breitung (2002). The test of Breitung (2002) is a generalization of the KPSS unit root test of Shin & Schmidt (1992), who note that the calculation of their $\hat{\eta}_{\tau}$ (0) test may be done "without the necessity to choose a rule for determining [the bandwidth parameter] *l*." Thus, Shin & Schmidt (1992) explicitly recognized, although only in passing, the importance and usefulness of tuning parameter free tests of the unit root hypothesis. Breitung (2002) demonstrated by simulations the superiority of his test relative to the variable addition test of Park & Choi (1988), so the below comparisons to existing tuning parameter free tests focus on the nonparametric Breitung (2002) test.

This paper presents a family of simple nonparametric tests of the autoregressive unit root hypothesis which are free of tuning parameters and improve upon existing tuning parameter free tests in terms of asymptotic local power. Compared to parametric tests, the proposed tests avoid many of the issues related to nuisance parameters, at least asymptotically, while maintaining competitive power properties. The nonparametric tests are constructed as a ratio of the sample variance of the observed series and that of a fractional partial sum (fractional difference of a negative order) of the series. Recently, fractional integration has been attracting increasing attention from both theoretical and empirical researchers in economics and finance, see e.g. Baillie (1996) or Robinson (2003) for reviews. In this paper, fractional integration techniques are exploited to construct a family of tests for an autoregressive unit root.²

The proposed procedure is nonparametric and does not rely on the specification of a particular data generating process or model. This feature in particular distinguishes the approach from the well known fully parametric testing approaches, e.g. the ADF test. Of course, this aspect is a consequence of the nonparametric nature of the variance ratio test statistic, and is important in practical applications where specification of the short-run dynamics is always a matter of some ambiguity and concern, since misspecified short-run dynamics leads to inconsistent estimation of the remainder of the model and hence to erroneous inferences on the order of integration. There is also no need to specify a bandwidth and kernel as in the Phillips-Perron type approach.

Another consequence of the nonparametric nature of the proposed procedure is that it is potentially useful in a much broader context than parametric tests, for example under nonlinear or fractionally integrated generating mechanisms for the underlying error process. It is well known that traditional parametric autoregression-based unit root tests often have difficulties in such circumstances since a very long autoregressive approximation may be needed to adequately model the process. On the other hand, the present approach, being nonparametric and asymptotically invariant to short-run dynamics, does not suffer from this particular problem and may therefore

 $^{^{2}}$ In the fractional integration literature, tests of the unit root hypothesis against alternatives of fractional integration have been developed which admit standard asymptotics, see e.g. Robinson (1994) and Tanaka (1999). This paper excludes such alternatives since the unit root hypothesis is nested within the class of autoregressive alternatives.

be expected to have better (finite-sample) properties when the underlying error processes is not of the AR or ARMA type. This is indeed confirmed in simulations below.

The proposed family of variance ratio tests is indexed by one parameter, d, which determines the order of the fractional partial summation. However, there are several important differences between this parameter and the tuning parameters in ADF regressions (lag length) or Phillips-Perron type tests (bandwidth and kernel). First of all, for any member of the family with d > 0, the nonparametric test is consistent. Secondly, the asymptotic distribution depends on d, and thus reflects the parameter chosen to implement the test. Thirdly, and consequently, since the asymptotic distribution depends on d and the test remains consistent for all d > 0, it is possible to analyze the (asymptotic local) power properties of the test for different values of d, and then try to locate a member of the family which is "tailored" to maximize power against relevant alternatives. The usual ADF/ADF-GLS or Phillips-Perron type tests have none of these three properties.

When d = 1 the Breitung (2002) test appears as a particular member of the proposed family. However, it is shown that members of the family with parameter d < 1 have higher asymptotic local power than Breitung's (2002) test. Furthermore, when d is small the asymptotic local power of the proposed nonparametric test is relatively close to, but naturally below, the parametric power envelope of Elliott et al. (1996). In particular, in the case with a linear time trend only 12% more observations would be required for the nonparametric variance ratio test with d = 0.1 to achieve asymptotic local power of one-half compared to the ADF-GLS test.

To document the finite sample properties of the methods proposed in this paper a simulation study is conducted. The simulations demonstrate that low values of d dominate higher values of d, and thus in particular the leading existing tuning parameter free test of Breitung (2002), although there is a size-power tradeoff in small samples with large negative AR or MA coefficients. Furthermore, and perhaps more surprisingly, the nonparametric variance ratio test compares favorably to the (nearly) optimal ADF-GLS test of Elliott et al. (1996) in terms of size-adjusted finite sample power when the two are compared on an even footing by applying the MAIC lag augmentation selection rule of Ng & Perron (2001) as modified by Perron & Qu (2007). However, the variance ratio tests suffer from size distortions in small samples (T = 100) with large negative MA or AR coefficients, although these size distortions are alleviated when considering the larger sample size (T = 500). It also appears from the simulations that the variance ratio test is superior to the ADF-GLS test against alternatives that are relatively far from the null. Thus, even though the ADF-GLS test has superior asymptotic local power properties, the need to select a tuning parameter (lag augmentation) and estimate nuisance parameters (serial correlation) reduces the power of the Dickey-Fuller type tests in more realistic settings. Finally, when the underlying errors are generated by nonlinear models, or when they are fractionally integrated, the nonparametric variance ratio test has similar size and better size-corrected power than both the Breitung (2002) and ADF-GLS tests, suggesting the usefulnes of the nonparametric test in more general circumstances.

In a separate set of simulations, a sieve bootstrap procedure is applied to the proposed variance ratio test (with sieve lag length chosen by the MAIC). The variance ratio test then has size properties that are as good as those of the ADF-GLS test using the MAIC lag selection rule. With the sieve bootstrap procedure, the finite sample power of the variance ratio test is similar to that of the ADF-GLS test and even superior in some cases, such as the important case of a model that includes a linear time trend and has moving average errors.

The remainder of the paper is laid out as follows. In the next section the variance ratio family of tests is presented along with the asymptotic distribution theory. Section 3 develops the relevant local asymptotic power analysis and introduces a GLS detrended version of the tests. In section 4 simulation evidence is presented to document the finite sample properties of the nonparametric test. Both sections 3 and 4 include comparisons to Breitung's (2002) test as well as (nearly) efficient parametric tests. Section 5 offers some concluding remarks. All proofs are gathered in the appendix.

2 The Nonparametric Variance Ratio Test

Suppose the observed univariate time series $\{y_t\}_{t=1}^T$ is generated by the model

$$y_t = \phi y_{t-1} + u_t, \quad t = 1, 2, ..., \quad y_0 = 0,$$
 (1)

where u_t is unobserved short-run dynamics to be defined precisely later.³ The unit root testing problem is the test of the null hypothesis

$$H_0: \phi = 1 \text{ vs. } H_1: |\phi| < 1.$$
 (2)

Consider, under the null hypothesis, the behavior of the observed time series $\{y_t\}_{t=1}^T$ generated according to (1) with $\phi = 1$ and also its fractional partial sum,

$$\tilde{y}_t = \Delta_+^{-d} y_t, \quad t = 0, 1, ..., \quad d > 0,$$
(3)

where we have used the definition

$$\Delta_{+}^{-d}x_{t} = (1-L)_{+}^{-d}x_{t} = \sum_{k=0}^{t-1} \frac{\Gamma(k+d)}{\Gamma(d)\Gamma(k+1)} x_{t-k} = \sum_{k=0}^{t-1} \pi_{k}(d) x_{t-k}$$

so that only values corresponding to a positive time index enters the fractional difference/summation expression. This is denoted by the subscript on the difference operator, i.e. Δ_+ , which is a truncated version of the binomial expansion in the lag operator L ($Lx_t = x_{t-1}$).

³The initial condition can be replaced by other well-known conditions that yield the same functional central limit theorems (4) and (5). Note that, if it is known that y_0 is likely to be small then, in the fully parametric setup, this knowledge will generate more discriminatory power for the unit root problem by applying the ADF-GLS tests of Elliott et al. (1996), see Müller & Elliott (2003). In that sense, the zero initial condition poses the greatest challenge for the proposed nonparametric test when compared to the ADF-GLS tests in simulations below.

It is well known that under regularity conditions on u_t , a functional central limit theorem is obtained for y_t and a similar (fractional) functional central limit theorem is obtained for \tilde{y}_t , i.e.

$$T^{-1/2}y_{\lfloor Ts \rfloor} \Rightarrow \sigma_y W_0(s), \quad 0 \le s \le 1, \tag{4}$$

$$T^{-1/2-d}\tilde{y}_{\lfloor T_s \rfloor} \Rightarrow \sigma_y W_d(s), \quad 0 \le s \le 1,$$
(5)

as $T \to \infty$ for some σ_y to be specified later. Here, $\lfloor \bullet \rfloor$ denotes the integer part of the argument, " \Rightarrow " means weak convergence in D[0, 1], and W_d is the type II fractional standard Brownian motion of order $d \ (> -1/2)$, see e.g. Marinucci & Robinson (2000), defined as

$$W_d(r) = 0, \text{ a.s.}, r = 0,$$
 (6)

$$W_d(r) = \frac{1}{\Gamma(d+1)} \int_0^r (r-s)^d dW_0(s), r > 0.$$
(7)

Note that with this definition W_0 is the standard Brownian motion.

It follows that the rescaled sample variances of y_t and \tilde{y}_t satisfy

$$T^{-2} \sum_{t=1}^{T} y_t^2 \Rightarrow \sigma_y^2 \int_0^1 W_0(s)^2 \, ds,$$
(8)

$$T^{-2(1+d)} \sum_{t=1}^{T} \tilde{y}_t^2 \Rightarrow \sigma_y^2 \int_0^1 W_d(s)^2 \, ds,$$
(9)

as $T \to \infty$, under the unit root null hypothesis (2). Thus, by forming the variance ratio,

$$\rho(d) = T^{2d} \frac{\sum_{t=1}^{T} y_t^2}{\sum_{t=1}^{T} \tilde{y}_t^2},$$
(10)

the nuisance parameter σ_y^2 is eliminated from the limiting distribution and there is no need to estimate serial correlation parameters. The statistic $\rho(d)$ in (10) defines the family of variance ratio statistics indexed by the fractional partial summation parameter, d.

The statistic (10) generalizes the idea of Shin & Schmidt (1992), Breitung (2002), and Taylor (2005) who used the ratio of the sample variance of y_t and that of the partial sum of y_t to eliminate the nuisance parameter σ_y^2 and avoid estimation of serial correlation parameters in testing for a unit root. Thus, setting d = 1, \tilde{y}_t is the partial sum of y_t and $\rho(1)$ is then (the inverse of) the statistic proposed by Breitung (2002), which is therefore also a member of the family of tests in (10). The same idea was applied by Vogelsang (1998*a*, 1998*b*) to test for structural breaks without estimating serial correlation parameters.

In recent work, Müller (2007, 2008) demonstrates some desirable properties of variance ratio type unit root test statistics such as (10), which are not necessarily shared by other statistics that have to estimate the long-run variance σ_y^2 . In particular, tests based on variance ratio type statistics are shown to be able to consistently discriminate between the unit root null and the stationary alternative.

To adjust for a non-zero mean and possibly deterministic time trend in the observed time series y_t , suppose $\{y_t\}_{t=1}^T$ is generated according to

$$y_t = \alpha' \delta_t + z_t, \quad t = 0, 1, ...,$$
 (11)

where z_t is unobserved and generated as y_t in (1). Here, $\delta_t = 0$ when there are no deterministic terms, $\delta_t = 1$ when there is a non-zero mean, and $\delta_t = [1, t]'$ when there is correction for a deterministic linear time trend. Thus, the family of variance ratio statistics corrected for deterministic terms is defined as in (10) but with residuals $\hat{y}_t = y_t - \hat{\alpha}' \delta_t$ replacing the observed time series y_t . For now, \hat{y}_t are OLS residuals, but in the next section GLS detrending is considered in the spirit of Elliott et al. (1996) which will in fact increase the power of the test, at least against near-integrated alternatives and for an important range of d values.

The following assumption on u_t in (1) is imposed throughout.

Assumption 1 The zero-mean process u_t is (weakly) stationary and ergodic and satisfies

(a)
$$0 < \sum_{k=-\infty}^{\infty} |\gamma_u(k)| < \infty$$
, where $\gamma_u(k) = E(u_t u_{t+k})$,
(b) $T^{-1/2} \sum_{t=1}^{\lfloor T_s \rfloor} u_t \Rightarrow \sigma_y W_0(s)$ for $\sigma_y > 0$ and all $0 \le s \le 1$,
(c) $T^{-1/2-d} \sum_{t=1}^{\lfloor T_s \rfloor} \Delta_+^{-d} u_t \Rightarrow \sigma_y W_d(s)$ for $d > 0$, $\sigma_y > 0$, and all $0 \le s \le 1$

Assumption 1 is similar to Condition C in Elliott et al. (1996) and holds under a variety of regularity assumptions. Sufficient conditions for (b) are given by, e.g., Phillips (1987*a*) and Phillips & Solo (1992), and for (c) by, e.g., Akonom & Gourieroux (1987), Davidson & de Jong (2000), and Marinucci & Robinson (2000). The conditions include mixing conditions and moment conditions (existence of a moment of order greater than two), and are satisfied by, e.g., stationary and invertible ARMA models. The conditions permit conditional heteroskedasticity in $\{u_t\}$ but rule out unconditional heteroskedasticity.

Under the null hypothesis that $\phi = 1$ and under Assumption 1 on u_t , (4) and (5) clearly hold. In that case, the limiting distribution of the variance ratio statistic $\rho(d)$ is easily derived and is presented in the following theorem.

Theorem 1 Let y_t be defined by (1) and (11), $\rho(d)$ by (10) with the residuals \hat{y}_t replacing y_t in (3) and (10), and let j = 0 when $\delta_t = 0$, j = 1 when $\delta_t = 1$, and j = 2 when $\delta_t = [1, t]'$. Under the null hypothesis (2), Assumption 1 on u_t , and for d > 0,

$$\rho(d) \Rightarrow U_j(d) = \frac{\int_0^1 B_j(s)^2 ds}{\int_0^1 \tilde{B}_{j,d}(s)^2 ds}, \quad j = 0, 1, 2,$$

as $T \to \infty$, where $B_0(s) = W_0(s)$ and the demeaned (j = 1) and detrended (j = 2) standard Brownian motions are defined as

$$B_{j}(s) = W_{0}(s) - \left(\int_{0}^{1} W_{0}(r) D_{j}(r)' dr\right) \left(\int_{0}^{1} D_{j}(r) D_{j}(r)' dr\right)^{-1} D_{j}(s), \quad j = 1, 2,$$

where $D_1(s) = 1$, $D_2(s) = [1, s]'$, and also $\dot{B}_{0,d}(s) = W_d(s)$ and

$$\tilde{B}_{j,d}(s) = W_d(s) - \left(\int_0^1 W_0(r) D_j(r)' dr\right) \left(\int_0^1 D_j(r) D_j(r)' dr\right)^{-1} \int_0^s \frac{(s-r)^{d-1}}{\Gamma(d)} D_j(r) dr, \quad j = 1, 2.$$

Note that in this theorem and below, weak convergence is for a fixed value of d. Also note that

$$\int_0^s \frac{(s-r)^{d-1}}{\Gamma(d)} dr = \frac{s^d}{d\Gamma(d)} = \frac{s^d}{\Gamma(d+1)},$$
$$\int_0^s \frac{(s-r)^{d-1}}{\Gamma(d)} r dr = \frac{s^{d+1}}{d(d+1)\Gamma(d)} = \frac{s^{d+1}}{\Gamma(d+2)},$$

so that the term $\int_0^s \frac{(s-r)^{d-1}}{\Gamma(d)} D_j(r) dr$ appearing in the definition of $\tilde{B}_{j,d}(s)$ for j = 1 and j = 2 corresponds to fractional powers of s. That is, $\tilde{B}_{j,d}(s)$, j = 1, 2, is a fractional Brownian motion less the trend correction term from an L_2 regression of a standard (non-fractional) Brownian motion on a fractional polynomial trend of order s^d when j = 1 and $[s^d, s^{d+1}]$ when j = 2.

The asymptotic distribution $U_j(d)$ of $\rho(d)$ given in Theorem 1 depends only on the choice of deterministic terms (j) and the parameter d, i.e. the order of fractional partial summation indexing the family of tests. Hence, the asymptotic distribution can easily be simulated to obtain quantiles for any member of the family characterized by the value of the parameter d. Quantiles of $U_j(d)$ for several values of the parameter d are presented in Table 1.

Table 1 about here.

A very important property of the variance ratio statistic (10) and its asymptotic distribution in Theorem 1 is that there is no need to specify or estimate any particular parametric or nonparametric model for the short-run dynamics in u_t . Thus, the statistic is asymptotically invariant to any shortrun dynamics in the data generating process for y_t . As a result, any hypothesis test based on a member of the family of variance ratio statistics will share this useful property.

Thus, consider using $\rho(d)$ as a test of the unit root hypothesis, i.e. of the null hypothesis (2), where large values of $\rho(d)$ are associated with rejection of H₀. The rejection region of the test and the alternatives against which it is consistent are given in the following theorem.

Theorem 2 Under the assumptions of Theorem 1 the test that rejects H_0 in (2) when $\rho(d) > CV_{j,\gamma}(d)$, where $CV_{j,\gamma}(d)$ is found from

$$P\left(U_{j}\left(d\right) > CV_{j,\gamma}\left(d\right)\right) = \gamma,\tag{12}$$

has asymptotic size γ and is consistent against the alternative H_1 in (2).

Note that, although the parameter d indexing the family of tests is specified by the econometrician, it is not a tuning parameter in the sense described in the introduction above. This is because the choice of d is reflected in the limiting distribution of the variance ratio statistic, unlike the tuning parameters, e.g. lag length and bandwidth parameters, in the Dickey-Fuller or Phillips-Perron unit root tests. Thus, it may be possible to locate a member of the family of tests which is tailored in such a way that power is maximized against relevant alternatives. Indeed, this is considered in the following asymptotic local power analysis, where results are provided which recommend d = 0.1, c.f. Theorem 3. See also the simulations in section 4 below. Another typical choice could be d = 1, i.e. partial summation, based on computational simplicity, which is (the inverse of) the statistic used by Breitung (2002) and Taylor (2005) to test for (seasonal) unit roots.

The variance ratio statistic (10) is related to many well known statistics such as the KPSS statistic of Kwiatkowski, Phillips, Schmidt & Shin (1992) and Shin & Schmidt (1992), and also earlier statistics such as the Durbin-Watson statistic, to mention just a few. Indeed, variance ratio type statistics have a very long tradition in time series analysis. However, there is a fundamental difference between those statistics and the variance ratio statistic in (10). The former statistics are mostly based on the ratio of the sample variance of y_t and that of Δy_t (corresponding to d = -1 in the present setup) and then the σ_y^2 that would appear in the limiting distribution is divided out by employing some form of long-run variance estimator. On the other hand, the statistic (10) is the ratio of the sample variance of y_t and that of the (fractional) partial sum of y_t , which implies that σ_y^2 cancels from the limiting distribution and there is no need to estimate serial correlation parameters or the long-run variance.

3 Asymptotic Local Power Analysis

In this section, the asymptotic local power of the autoregressive unit root test described in Theorems 1 and 2 is analyzed to guide the choice of the parameter d. Since d is the only parameter indexing the family of tests and the only parameter needed to calculate the variance ratio test statistic (10), and is also the only parameter in the asymptotic distribution, it is of interest to examine the power function for a range of values of d. In particular, one might ask if there is a member of the family with maximum (within the family) power against relevant alternatives, i.e. if there is a power maximizing value of d. This value could then be chosen by the researcher to "tailor" the test to obtain high power, i.e. to select the member of the family with the best power properties.

Instead of attempting to calculate the exact power function of the test as a function of d, the power is described qualitatively using local-to-unity asymptotics. To obtain non-degenerate power under the alternative, consider the well-known sequence of local alternatives where $\{y_t\}_{t=1}^T$

is generated according to

$$y_t = \phi_T y_{t-1} + u_t, \quad \phi_T = 1 - c/T,$$
(13)

i.e. near-integrated alternatives with some $c \ge 0$, c.f. Chan & Wei (1987) and Phillips (1987b). For any fixed T, y_t is stationary (the alternative) provided T is large enough that $c/T \in (0, 2)$. On the other hand, y_t is nonstationary (the null hypothesis) in the limit since $\phi_T \to 1$ when $T \to \infty$. Thus, the model (13) provides alternatives local to $\phi = 1$. Under (13) and Assumption 1, sample moments such as (8) have limiting distributions which are expressed in terms of the Ornstein-Uhlenbeck process

$$J_{0,c}(s) = W(s) - c \int_0^s e^{-c(s-r)} W(r) dr, \quad J_{0,c}(0) = 0.$$
(14)

The next two subsections first consider the asymptotic local power of the above family of variance ratio tests, and subsequently introduce a GLS detrended version to be compared to the GLS detrended ADF test of Elliott et al. (1996).

3.1 Asymptotic Local Power of the Variance Ratio Test

The following theorem presents the asymptotic distribution of the variance ratio statistic under the near-integrated local alternatives.

Theorem 3 Let the assumptions of Theorem 1 be satisfied except (13) replaces (1) in the definition of y_t (or z_t if $\delta_t \neq 0$). Then, as $T \to \infty$,

$$\rho(d) \Rightarrow U_{j,NI}(c,d) = \frac{\int_0^1 J_{j,c}(s)^2 \, ds}{\int_0^1 \tilde{J}_{j,c,d}(s)^2 \, ds}, \quad j = 0, 1, 2,$$

where $J_{0,c}(s)$ is the Ornstein-Uhlenbeck process (14), $J_{1,c}(s)$, $J_{2,c}(s)$ are the demeaned (j = 1) and detrended (j = 2) Ornstein-Uhlenbeck processes,

$$J_{j,c}(s) = J_{0,c}(s) - \left(\int_{0}^{1} J_{0,c}(r) D_{j}(r)' dr\right) \left(\int_{0}^{1} D_{j}(r) D_{j}(r)' dr\right)^{-1} D_{j}(s), \quad j = 1, 2$$

and

$$\tilde{J}_{0,c,d}(s) = W_d(s) - c \int_0^s e^{-c(s-r)} W_d(r) dr,$$

$$\tilde{J}_{j,c,d}(s) = \tilde{J}_{0,c,d}(s) - \left(\int_0^1 J_{0,c}(r) D_j(r)' dr\right) \left(\int_0^1 D_j(r) D_j(r)' dr\right)^{-1} \int_0^s \frac{(s-r)^{d-1}}{\Gamma(d)} D_j(r) dr, \quad j = 1, 2$$

It follows from Theorem 3 that the asymptotic local power of any member of the family of variance ratio tests can be described in terms of $U_{j,NI}(c,d)$ whose distribution is a continuous

function of the local noncentrality parameter $c \ge 0$ and the index d > 0. Note that $U_{j,NI}(0,d) = U_j(d)$, j = 0, 1, 2. Also note that the process $\tilde{J}_{0,c,d}(s)$ appearing in Theorem 3 is a fractional version of the well known Ornstein-Uhlenbeck process $J_{0,c}(s)$, see e.g. Buchmann & Chan (2007). The local asymptotic power function of any member of the family of variance ratio tests can thus be calculated as

$$P\left(U_{j,NI}\left(c,d\right)>CV_{j,\gamma}\left(d\right)\right),$$

where $CV_{j,\gamma}(d)$ is defined in Theorem 2.

Figure 1 about here.

Figure 1 displays simulated asymptotic local power curves for several members of the variance ratio test family (with $\gamma = 0.05$) as functions of the local noncentrality parameter, $c \ge 0$. The simulated power functions are based on 20,000 Monte Carlo replications of (13) with T = 500, u_t *i.i.d.* standard normal, and either no deterministic terms (Panel A), constant mean (Panel B), or linear trend (Panel C). In each graph, the power curves are drawn for $d \in \{0.1, 0.25, 0.5, 1.0\}$, where d = 1 is the test of Breitung (2002).

From Figure 1 it appears that the asymptotic local power of the variance ratio test is monotonic in d, and that d = 0.1 is the "power maximizing" choice among those power functions depicted, in the sense that it has uniformly (in c) higher power relative to d = 0.25, d = 0.5, and d = 1.0. It should be noted that other choices of d conform to the monotonicity apparent in Figure 1 although the gain in power from choosing an even smaller value of d is minor. Furthermore, it also seems unwise to choose d too small, since then d acts as if it depends (inversely) on the sample size which may distort the size properties of the test and result in poor size properties in finite samples. Obviously, if d = 0 the test statistic degenerates.⁴ Thus, Figure 1 suggests that d = 0.1 provides a good choice of the parameter d indexing the family of tests, in the sense that local asymptotic power is better uniformly in c relative to higher values of d. In section 4 below, further support of the d = 0.1 test relative to Breitung's (2002) test (d = 1) is presented based on simulation evidence.

Finally, Figure 1 clearly demonstrates that significant power gains can be achieved by considering non-integer values of d < 1. Comparing the d = 1 curve with the other curves, it is seen that d = 1 provides the lowest power in all the panels of Figure 1. In other words, the variance ratio test with d = 1 suggested by Breitung (2002) for testing the unit root hypothesis against nonlinear

⁴In fact, $\rho(0) = 1$ and $\lim_{d\to 0} d^{-1}(\rho(d)^{-1} - 1) = \lim_{d\to 0} \left[d\sum_{t=1}^{T} (d^{-1}(\Delta_{+}^{-d} - 1)y_t)^2 + 2\sum_{t=1}^{T} y_t d^{-1}(\Delta_{+}^{-d} - 1)y_t\right]/\sum_{t=1}^{T} y_t^2 = 2\sum_{j=1}^{T-1} j^{-1}r_j$, where r_j is the j'th sample autocorrelation and $\lim_{d\to 0} d^{-1}(\Delta_{+}^{-d} - 1) = \sum_{j=1}^{t-1} j^{-1}L^j$. The statistic $\sum_{j=1}^{T-1} j^{-1}r_j$ is well known as a test in fractionally integrated models, e.g. Robinson (1994) and Tanaka (1999), although there it is used as a test of I(0), not I(1). The asymptotic distribution of this statistic under the unit root null can be derived using results of Hualde (2007, Lemma 2), but simulations indicate that it is very sensitive to short-run dynamics in u_t , so this is not pursued further here.

models can be vastly improved upon, at least against near-integrated alternatives, by admitting non-integer values of d < 1.

3.2 GLS Detrending and Comparison to ADF-GLS Tests

Now consider applying GLS detrending to correct for deterministic terms instead of the simple OLS detrending above. Thus, for any generic series $\{x_t\}_{t=1}^T$ and some constant \bar{c} define $x_{\bar{c},1} = x_1$ and $x_{\bar{c},t} = x_t - (1 - \bar{c}/T) x_{t-1}, t = 2, ..., T$. With this definition the observed GLS detrended time series, denoted $\{\hat{y}_{\bar{c},t}\}_{t=1}^T$, is given by

$$\hat{y}_{\bar{c},t} = y_t - \tilde{\alpha}' \delta_t,\tag{15}$$

where

$$\tilde{\alpha} = \arg\min_{\alpha} \sum_{t=1}^{T} \left(y_{\bar{c},t} - \alpha' \delta_{\bar{c},t} \right)^2$$

The use of GLS detrended time series for the ADF test was proposed by Elliott et al. (1996) who in particular suggest $\bar{c} = 7$ and $\bar{c} = 13.5$ for $\delta_t = 1$ and $\delta_t = [1, t]'$, respectively, resulting in the ADF-GLS test. These values of \bar{c} correspond to the local point alternatives against which the local asymptotic power for significance level 5% equals one-half. With respect to the choice of lag augmentation for the ADF-GLS tests, i.e. the tuning parameter, Ng & Perron (2001) and Perron & Qu (2007) show that the tests have both good size and power properties when employing a modified version of the well known Akaike information criterion, which is applied in the simulations below. In the asymptotic comparisons, the lag augmentation is (unrealistically, of course) assumed to be chosen correctly and optimally, and has no effect on asymptotic local power.

Consider constructing the variance ratio test based on the GLS detrended series (15). That is,

$$\rho\left(\bar{c},d\right) = T^{2d} \frac{\sum_{t=1}^{T} \hat{y}_{\bar{c},t}^2}{\sum_{t=1}^{T} \hat{y}_{\bar{c},t}^2},\tag{16}$$

where $\tilde{y}_{\bar{c},t} = \Delta_+^{-d} \hat{y}_{\bar{c},t}$ similarly to (3). The distribution of the GLS detrended variance ratio test (16) under the sequence of local alternatives (13) depends on the stochastic processes

$$\begin{aligned} V_{\bar{c},c}\left(s\right) &= J_{0,c}\left(s\right) - b_{1}s,\\ \tilde{V}_{\bar{c},c,d}\left(s\right) &= \tilde{J}_{0,c,d}\left(s\right) - b_{1}\frac{s^{d+1}}{\Gamma(d+2)},\\ b_{1} &= \frac{(1+\bar{c})}{1+\bar{c}+\bar{c}^{2}/3}J_{0,c}\left(1\right) + \frac{\bar{c}^{2}}{1+\bar{c}+\bar{c}^{2}/3}\int_{0}^{1}rJ_{0,c}\left(r\right)dr, \end{aligned}$$

and is presented in the next theorem.

Theorem 4 Let the assumptions of Theorem 3 be satisfied except y_t is GLS detrended as in (15) and the variance ratio statistic is given by (16). Then, as $T \to \infty$,

$$\rho(\bar{c}, d) \Rightarrow U_{j,GLS}(\bar{c}, c, d), \quad j = 1, 2,$$

where

$$U_{1,GLS}(\bar{c}, c, d) = U_{0,NI}(c, d),$$
$$U_{2,GLS}(\bar{c}, c, d) = \frac{\int_0^1 V_{\bar{c},c}(s)^2 ds}{\int_0^1 \tilde{V}_{\bar{c},c,d}(s)^2 ds},$$

and $U_{0,NI}(c,d)$ is defined in Theorem 3.

To implement the GLS detrending procedure for the variance ratio test, a recommendation regarding the choice of local detrending parameter \bar{c} is needed. Following Elliott et al. (1996), the values of $\bar{c} = c$ that attain asymptotic local power equal to one-half at 5% significance level are presented in Panel A of Table 2 for $\delta_t = 1$ and $\delta_t = [1, t]'$ and several values of d. These values of $\bar{c} = c$ are those for which the power envelope type function $P(U_{j,GLS}(\bar{c}, \bar{c}, d) > CV_{j,0.05}(\bar{c}, d))$ is equal to one-half at 5% significance level, where $CV_{j,\gamma}(\bar{c}, d)$ satisfies $P(U_{j,GLS}(\bar{c}, 0, d) > CV_{j,\gamma}(\bar{c}, d)) = \gamma$.

Table 2 about here.

Critical values of the variance ratio test for the particular \bar{c} and d values presented in Panel A of Table 2 are presented in Panel B of Table 2 for significance levels $\gamma = 1\%, 5\%$, and 10%. Note that the table presents the critical values for j = 2 only, since the j = 1 case has the same asymptotic null distribution and hence the same critical values as j = 0 in Table 1.

Figure 2 about here.

In Figure 2 the asymptotic local power functions of the GLS detrended variance ratio tests with $d \in \{0.001, 0.1, 1\}$ are presented for the no deterministics case (Panel A), the constant mean case (Panel B), and the linear trend case (Panel C). The Breitung (2002) test (d = 1) is included for comparison with existing tuning parameter free tests, and the test with d = 0.001 is included to examine how close the asymptotic local power curve of the nonparametric variance ratio test can be pushed towards the parametric power envelope. Also included are the local power functions of the Dickey-Fuller and GLS detrended Dickey-Fuller tests. The local power functions of the latter are indistinguishable from the parametric power envelope, c.f. Elliott et al. (1996). All the asymptotic local power functions are simulated based on 20,000 Monte Carlo replications with T = 500.

Note that, as observed by Breitung & Taylor (2003), the Breitung (2002) test does not benefit from GLS detrending – on the contrary – whereas the variance ratio test based on fractional partial summation (e.g. d = 0.1) does benefit significantly from GLS detrending in terms of asymptotic local power. In both the case with mean correction (Panel B) and the case with trend correction (Panel C), the asymptotic local power of the variance ratio test with d = 0.1 is approximately the same as that of the Dickey-Fuller test. When GLS detrending is employed in the construction of the variance ratio test the power is increased, and in particular the power of the GLS detrended variance ratio test with d = 0.1 is significantly higher than that of the Dickey-Fuller test although still below that of the GLS detrended Dickey-Fuller test. In all three panels of Figure 2, the GLS detrended variance ratio tests conform to the same monotonicity in d as in Figure 1. Thus, compared to Figure 1, the asymptotic local power of the GLS detrended variance ratio test with d < 1 is even more superior to Breitung's (2002) test than its OLS detrended counterpart.

One method to measure and compare the asymptotic local power of the GLS detrended variance ratio test with that of Breitung's (2002) test and the ADF-GLS tests (whose asymptotic local power essentially coincides with the parametric power envelope) is to calculate the Pitman asymptotic relative efficiency (ARE) of the d = 0.1 and d = 1 tests relative to the ADF-GLS test. In the framework of asymptotic local power, this is done by comparing the values of c at which the tests obtain a specified power such as one-half following Elliott et al. (1996). The interpretation is that if the Pitman ARE of test A relative to test B is 1.25, then 25% more observations would be needed to obtain asymptotic local power of one-half using test A instead of test B. In the constant mean case, using 5% tests, the Pitman ARE of the VR-GLS test with d = 0.1 and the Breitung (2002) test (d = 1) relative to the ADF-GLS test are 1.34 and 2.97. In the linear trend case the corresponding AREs are 1.12 and 2.07. Thus, in the constant mean case 122% more observations would be needed and in the linear trend case 85% more observations would be needed for the Breitung (2002) (d = 1)test than for the VR-GLS test with d = 0.1 to achieve asymptotic local power of one-half. Perhaps more surprisingly, in the linear trend case only 12% more observations would be required for the VR-GLS test with d = 0.1 than for the ADF-GLS test to achieve asymptotic local power of one-half.

It is clear from the above asymptotic analysis that the nearly optimal ADF-GLS test is more powerful in a local asymptotic sense than the nonparametric GLS detrended variance ratio test with d = 0.1. However, these considerations assume that the tuning parameter, i.e. lag length, in the ADF-GLS test is chosen optimally, even though in any applied situation the correct/optimal lag length is unknown. It is well known that in more realistic scenarios where the lag length is unknown and must be chosen/estimated from data, using e.g. an information criterion, and serial correlation nuisance parameters must be estimated, the properties of the Dickey-Fuller type tests may deteriorate relative to the above "perfect knowledge" case. Indeed, they may be inferior to tests which do not require selection of tuning parameters or estimation of serial correlation parameters.

4 Finite Sample Performance

The time series y_t is simulated according to the autoregressive model

$$y_t = \phi y_{t-1} + u_t, \quad t = 1, ..., T, \quad y_0 = 0.$$
 (17)

Following Breitung (2002), several different linear and nonlinear generating mechanisms are considered for u_t , in particular,

$$AR: u_t = au_{t-1} + \varepsilon_t, \quad t = 1, \dots, T,$$
(18)

$$MA: u_t = \varepsilon_t + a\varepsilon_{t-1}, \quad t = 1, ..., T,$$
(19)

GARCH:
$$u_t = h_t^{1/2} \varepsilon_t$$
, $h_t = 1 + ah_{t-1} + (0.95 - a) u_{t-1}^2$, $t = 1, ..., T$, (20)

$$Bilin: u_t = a\varepsilon_{t-1}u_{t-1} + \varepsilon_t, \quad t = 1, ..., T,$$
(21)

$$VCM: u_t = \alpha_t u_{t-1} + \varepsilon_t, \quad \alpha_t = a \cos\left(2\pi t/T\right), \quad t = 1, ..., T,$$
(22)

$$\text{TAR}: u_t = \begin{cases} au_{t-1} + \varepsilon_t & \text{if } |u_{t-1}| < 2, \\ -au_{t-1} + \varepsilon_t & \text{if } |u_{t-1}| \ge 2, \end{cases} \quad t = 1, ..., T,$$
(23)

$$Frac: u_t = \Delta_+^{-a} \varepsilon_t, \quad t = 1, ..., T.$$
(24)

The models (18) and (19) are the traditional autoregressive (AR) and moving average (MA) models of order one for u_t with coefficient a. In (20), u_t is serially uncorrelated but exhibits time-varying variance, GARCH, of order (1,1). The parameterization is such that the sum of the two GARCH parameters (here denoted a and (0.95 - a)) equals 0.95 reflecting typical empirical values. The models (18)-(20) clearly satisfy Assumption 1.

Model (21) is the bilinear (Bilin) model with parameter a, (22) is a variable coefficient model (VCM) where the autoregressive coefficient is cyclical with amplitude determined by the parameter a, and (23) is the threshold autoregressive (TAR) model with parameter equal to a or -a determined by the threshold condition. Under model (24), u_t is fractionally integrated of order a. Finally, y_t is also simulated from the model

STUR:
$$y_t = \alpha_t y_{t-1} + \varepsilon_t$$
, $\alpha_t = a + (\phi - a) \alpha_{t-1} + 0.05 \eta_t$, $t = 1, ..., T$, (25)

where $y_0 = 0$ and $E(\alpha_t) = a/(1 - \phi + a)$, which is a variant of the stochastic unit root model considered by, e.g., McCabe & Tremayne (1995) and Granger & Swanson (1997). Some of the nonlinear models considered here induce trends in y_t , see e.g. Granger & Anderson (1978), so only the case with correction for a linear trend is considered for the nonlinear models. Although some of these models do not satisfy the conditions in Assumption 1, the variance ratio test may still provide a valid test, but this is not known. Nonetheless, following Breitung (2002), we also consider the models (21)-(25) even though the theoretical properties under those models are not known. In all models, ε_t and η_t are *i.i.d.* standard normal and independent. The sample sizes considered are T = 100 and T = 500, and 20,000 Monte Carlo replications are used in the simulations. Throughout, a $\gamma = 5\%$ nominal significance level is employed. All calculations were made in Ox, see Doornik (2006).

In all the simulations, comparisons are made not only to existing tuning parameter free tests, but also to the well known ADF test and to the ADF-GLS test of Elliott et al. (1996). To make the tests comparable, the lag augmentations (say k) in the ADF and ADF-GLS regressions are chosen using the data dependent modified Akaike information criterion (MAIC) of Ng & Perron (2001) who show that this criterion "dominates all other criteria from both theoretical and numerical perspectives." In particular, the further modification of Perron & Qu (2007) was applied to achieve even better finite sample properties, and the lag augmentation was chosen to optimize the MAIC with $k_{\min} = 0$ and $k_{\max} = \lfloor 12(T/100)^{1/4} \rfloor$ as in Ng & Perron (2001) and Perron & Qu (2007). Note that, in the simulations, this upper bound binds rarely for the small sample size (T = 100) and almost never for the larger sample size (T = 500). Also note that the ADF-GLS test favors small initial conditions, see Müller & Elliott (2003), so in that sense the zero initial condition poses the greatest challenge for the proposed nonparametric test when compared to the ADF-GLS test.

Tables 3 and 4 about here.

Tables 3 and 4 present the simulated sizes and size-adjusted rejection frequencies with T = 100for the constant mean and the linear trend cases, respectively, under the simple autoregressive and moving average models (18) and (19). The results are reported for the variance ratio statistic with d = 0.1 (denoted $\rho(0.1)$), the corresponding GLS detrended variance ratio statistic (denoted $\rho(\bar{c}, 0.1)$), the Breitung (2002) test (BT), and the ADF and ADF-GLS tests using the MAIC to select lag augmentation. For each statistic, entries in the rows marked $\phi = 1.00$ are the rejection frequencies under the unit root null hypothesis, i.e. the sizes of the tests, and all other entries are size-adjusted finite sample rejection frequencies.⁵

The results of Table 3 for the constant mean case show that the variance ratio test has some size distortion in the presence of a negative moving average or autoregressive coefficient. The size issue is also present in Breitung (2002) and so it is somewhat expected, even though the BT test is less size distorted than the variance ratio tests with small d. On the other hand, the ADF and ADF-GLS tests handle the size issue very well, and have sizes very close to the nominal level for all the models considered in this table. With respect to the size-adjusted finite sample power of the tests, the variance ratio tests with d = 0.1, and especially the GLS detrended version, clearly dominate the BT test. In fact, in some cases, the $\rho(\bar{c}, 0.1)$ test is actually superior to the Dickey-Fuller type tests. Thus, the size control of the ADF-GLS tests, which results from the application of

⁵The unadjusted rejection frequencies are not shown here for reasons of space, but are available from the author upon request.

the MAIC lag selection criterion, comes at the price of a decrease in power, at least for this sample size, T = 100. Specifically, for $\phi = 0.90$, the finite sample rejection frequencies of the $\rho(\bar{c}, 0.1)$ test are very similar to those of the ADF-GLS test, but for $\phi \leq 0.8$ the $\rho(\bar{c}, 0.1)$ test clearly outperforms the ADF-GLS test. For the latter range of ϕ -values, the finite sample power of the $\rho(\bar{c}, 0.1)$ test is about 10-20% higher than that of the ADF-GLS test.

In Table 4, presenting the results for the linear trend case, it is clear that the close proximity of the asymptotic local power function of the $\rho(\bar{c}, 0.1)$ test in this case to the parametric power envelope carries over to the simulation results. In particular, the results from Table 3 are reinforced here: the size distortion remains in the presence of negative autoregressive or moving average coefficients, and the finite sample power of the $\rho(\bar{c}, 0.1)$ test is higher than that of the ADF-GLS test when $\phi \leq 0.8$. Again, the GLS detrended variance ratio test with d = 0.1 clearly dominates the BT test in terms of finite sample rejection frequency, although there is a size-power tradeoff in the presence of large MA or AR coefficients. The results presented in Tables 3 and 4 thus demonstrate that, at the cost of some size distortion in specific cases, significant power gains may be obtained in small samples by considering the proposed variance ratio test.

Tables 5 and 6 about here.

In Tables 5 and 6, laid out as the previous two tables, the simulated sizes and size-adjusted rejection frequencies for sample size T = 500 are reported under the same models as in Tables 3 and 4. The results for the constant mean case in Table 5 show that the size distortion evident in the smaller sample has almost vanished, and all the tests now have reasonable size properties. The power of the ADF-GLS test relative to the variance ratio tests has increased dramatically for this larger sample size, presumably due to better lag augmentation selection, and now dominates that of the variance ratio tests for small deviations from the null. In particular, the ADF-GLS test now has somewhat higher finite sample power against $\phi = 0.98$ and $\phi = 0.96$. For $\phi \leq 0.94$, both the $\rho(\bar{c}, 0.1)$ and ADF-GLS tests reject in very nearly all replications.

The results in Table 6 for the linear trend case with T = 500 show that the $\rho(\bar{c}, 0.1)$ test remains very competitive in the presence of a linear trend, even with the larger sample size and therefore better lag augmentation selection by the ADF-GLS test. The variance ratio tests are much less over-sized when T = 500 compared to T = 100 in Table 4, and size distortion is now only significant for the largest negative moving average root. With respect to finite sample power, the rejection frequencies of the $\rho(\bar{c}, 0.1)$ and ADF-GLS tests are similar for all alternatives shown in the table.

In both Tables 5 and 6 the BT test is dominated by the variance ratio test with d = 0.1, with or without GLS detrending. For this larger sample size, there is much less size distortion for d = 0.1and so the size power tradeoff is less pronounced resulting in the superiority of the $\rho(\bar{c}, 0.1)$ test due to its much higher size-adjusted power.

Tables 7 and 8 about here.

Tables 7 and 8 present simulation results for the models (20)-(25). Since some of the nonlinear models induce trends in the observed time series, only the linear trend case is considered here. The results for the smaller sample size, T = 100, in Table 7 emphasize the usefulness of the nonparametric variance ratio test. All tests have similar size properties, but it is worth remarking that the $\rho(\bar{c}, 0.1)$ test is clearly superior in terms of finite sample power, especially against alternatives far from the null.

The results for the variance ratio tests under the GARCH model (20) are similar to the results for the *i.i.d.* error case in Table 4, whereas the ADF-GLS test has somewhat reduced power in the presence of GARCH. This is especially visible against alternatives far from the null, as in the *i.i.d.* case in Table 4. Furthermore, the $\rho(\bar{c}, 0.1)$ test (and the $\rho(0.1)$ test) continues to dominate the BT test in terms of power. For the TAR model (23), the situation is very similar to that for the GARCH model or the *i.i.d.* case, where the finite sample powers of the $\rho(\bar{c}, 0.1)$ and ADF-GLS tests are similar for $\phi = 0.9$ and $\phi = 0.8$ but the $\rho(\bar{c}, 0.1)$ test is superior for $\phi \leq 0.7$, and both tests are superior to the BT test.

In the bilinear model (21), GLS detrending appears to have no effect on power. Under this model, the finite sample power of the variance ratio tests (with or without GLS detrending) is similar to that of the Dickey-Fuller type tests for $\phi \ge 0.8$, but for moderate to large deviations from the null, i.e. when $\phi \le 0.7$, the variance ratio tests are clearly superior. Once again, the finite sample power of the variance ratio tests with d = 0.1 is much higher than that of the BT test. In the VCM and STUR models (22) and (25), the $\rho(\bar{c}, 0.1)$ test has similar or higher finite sample power than the ADF and ADF-GLS tests and clearly higher power than the BT test. Note that, in the STUR model, GLS detrending appears to have no significant effect on the power of the tests.

For the model with fractionally integrated errors (24), it may be expected that the variance ratio test is superior to the other tests since it is based on fractional partial summation of the data. In the case with negative fractional integration order (a = -0.1) all the tests are slightly size distorted, and in terms of finite sample size-adjusted power the variance ratio test with d = 0.1 is much superior to the other tests. For example, against the alternative $\phi = 0.8$, the $\rho(\bar{c}, 0.1)$ test has size-corrected rejection frequency that is 0.22 higher than that of the ADF-GLS test and 0.34 higher than that of the BT test. When the integration order of the errors is positive (a = 0.1), all the tests are slightly under-sized and the size-corrected rejection frequencies of the $\rho(\bar{c}, 0.1)$ test are similar to those of the ADF-GLS test for $\phi = 0.9$ and $\phi = 0.8$, but for $\phi \leq 0.7$, the $\rho(\bar{c}, 0.1)$ test has higher finite sample power.

Finally, for the larger sample size, T = 500, the results in Table 8 confirm the previous results for the GARCH, VCM, and TAR models: the $\rho(\bar{c}, 0.1)$ test and the ADF-GLS test both have excellent size properties, the two tests have similar size-adjusted power for small deviations from the null hypothesis, and they both have better finite sample power than the BT test. However, the $\rho(\bar{c}, 0.1)$ and ADF-GLS tests now also have similar power when moving further away from the null. For the bilinear model, size is again well controlled by all the tests, but the GLS detrended tests (both $\rho(\bar{c}, 0.1)$ and ADF-GLS) have very low power. Indeed, this is the only case in which the BT test is significantly better than the $\rho(\bar{c}, 0.1)$ test. For the STUR model, all tests (including the ADF and ADF-GLS tests) exhibit severe size distortions when a = 0.1 but not when a = 0.5, and all tests have similar size-adjusted power except the BT test which has much lower power when a = 0.5.

In general, it is apparent from the simulations so far that the nonparametric variance ratio test is useful and that non-trivial power gains may be obtained relative to existing tuning parameter free tests (here the BT test). More surprisingly, it appears that the variance ratio test even rivals the ADF-GLS test of Elliott et al. (1996) in sample sizes that are relevant for empirical research, although there is a size-power tradeoff. Thus, even though the ADF-GLS test has superior asymptotic local power properties, as documented in section 3 above, the need to select a tuning parameter (lag augmentation) and estimate nuisance parameters (serial correlation) reduces the power of Dickey-Fuller type tests in more realistic settings. Although the finite sample power loss of the ADF-GLS test relative to the power envelope is somewhat alleviated in larger samples, where the MAIC comes closer to selecting the optimal (but unknown to the researcher) lag augmentation, it remains an issue and the variance ratio test is still able to achieve similar power without the need to select any tuning parameters.

4.1 Bootstrapping the Variance Ratio Test

To reduce the size distortion found above in the presence of negative moving average or autoregressive coefficients, a bootstrap procedure can be applied. The sieve bootstrap algorithm applied here follows that of Chang & Park (2003).⁶

Let \hat{u}_t denote the first difference of the GLS detrended observed time series (the same procedure applies to OLS detrended series). First, fit the approximating sieve autoregression

$$\hat{u}_t = \alpha_1 \hat{u}_{t-1} + \ldots + \alpha_p \hat{u}_{t-p} + \varepsilon_t \tag{26}$$

by OLS and denote by $\{\hat{\varepsilon}_t\}_{t=1}^T$ the residuals from (26). It is important to base the bootstrap procedure on the first differences of the detrended time series since, as shown by Basawa, Mallik, McCormick, Reeves & Taylor (1991), bootstrap samples generated without the unit root restriction make bootstrap unit root testing procedures inconsistent. The lag length p in (26) is chosen to be the same as that in the ADF-GLS tests with the MAIC selection criterion.

⁶This bootstrap procedure was also applied to the ADF-GLS test with the MAIC lag selection. However, only very small size improvements were obtained at the cost of a large loss in power, so those results are not reported here.

Next, bootstrap errors $\{\varepsilon_t^b\}_{t=1}^T$ are constructed by resampling from the centered residuals $\{\hat{\varepsilon}_t - \bar{\hat{\varepsilon}}_t\}_{t=1}^T$ from (26) with replacement. Then $\{\hat{u}_t^b\}_{t=1}^T$ is generated from $\{\varepsilon_t^b\}_{t=1}^T$ using the fitted autoregression, i.e. by

$$\hat{u}_t^b = \hat{\alpha}_1 \hat{u}_{t-1}^b + \ldots + \hat{\alpha}_p \hat{u}_{t-p}^b + \varepsilon_t^b, \quad t = p+1, \ldots, T,$$

where $\hat{\alpha}_1, \ldots, \hat{\alpha}_p$ are the estimated parameters from (26) and the initial values $\hat{u}_1^b, \ldots, \hat{u}_p^b$ are set to zero for simplicity. Finally, the bootstrap sample $\{y_t^b\}_{t=1}^T$ is obtained by partial summation, i.e.

$$y_t^b = y_0^b + \sum_{s=1}^t \hat{u}_s^b, \quad t = 1, \dots, T,$$

with the initial condition $y_0^b = 0$. For a discussion of the initial conditions imposed on \hat{u}_t^b and y_t^b , see Chang & Park (2003, p. 390).

The bootstrap sample $\{y_t^b\}_{t=1}^T$ is then GLS detrended and the variance ratio statistic, denoted $\rho_b(\bar{c},d)$, is calculated from the GLS detrended bootstrap sample as described in the previous sections. To implement the bootstrap test, the bootstrap procedure is repeated B = 999 times and the simulated bootstrap p-value is then computed as the percentage of bootstrap statistics that exceed the actual statistic $\rho(\bar{c},d)$ from the observed sample, i.e., $\hat{p} = B^{-1} \sum_{b=1}^{B} 1(\rho_b(\bar{c},d) > \rho(\bar{c},d))$, where $1(\cdot)$ is the indicator function. The bootstrap test rejects if $\hat{p} < \gamma$.

Note that the bootstrap procedure described here has the additional advantage relative to the test described in Theorems 1 and 2 based on the asymptotic distribution that a *p*-value is readily obtained as part of the procedure. Thus it might be thought of as more informative. Also note that the bootstrap procedure depends on the tuning parameter p in the sieve approximation (26), although this is partly alleviated by the use of the MAIC to choose p. However, the variance ratio test $\rho(\bar{c}, d)$ is still tuning parameter free since the test statistic does not depend on any parameters that are not reflected in the asymptotic distribution. The bootstrap procedure is implemented to approximate the finite sample distribution of $\rho(\bar{c}, d)$, and the lag length p in (26) is a parameter in that approximation.

Tables 9 and 10 about here.

Tables 9 and 10 present the simulated rejection frequencies (not size-adjusted) with T = 100under the MA model (19) with coefficient $a \in \{-0.8, -0.6, \dots, 0.8\}$. The BT, $\rho(0.1)$, and $\rho(\bar{c}, 0.1)$ tests apply the sieve bootstrap algorithm described above. The MA model was chosen since it caused the most size distortion, and since MA errors are relevant for many economic time series as argued by Ng & Perron (2001). For instance, omitted outliers may cause MA(1) type characteristics in observed time series, c.f. Franses & Haldrup (1994).

The results in Table 9 for the constant mean case show that the size distortion is now almost gone. In particular, the GLS detrended variance ratio test has size equal to 7% when the MA coefficient is -0.8, where the ADF-GLS test has size equal to 12%. The power simulations show an advantage to the ADF-GLS test, which is, at least in part, due to the inflated size of the test and the fact that the rejection frequencies are not size-adjusted. In Table 10, presenting the results for the linear trend case, all the tests are equally size distorted for the largest negative MA coefficient, $\theta = -0.8$, but show only minor size distortion for the other values of the MA coefficient. In terms of power, the $\rho(\bar{c}, 0.1)$ test actually outperforms the ADF-GLS test when the MA coefficient is either small or positive. In the case of a negative coefficient the $\rho(\bar{c}, 0.1)$ and ADF-GLS tests have almost identical power.

Tables 11 and 12 about here.

In Tables 11 and 12, laid out as the previous two tables, the simulated rejection frequencies for sample size T = 500 are reported. The results show excellent size control for all the tests and for all the MA coefficients considered. In terms of power, the conclusions from the smaller sample size are confirmed: The ADF-GLS test is superior in the constant mean case, whereas the GLS detrended variance ratio test is superior in the linear trend case with small or positive MA coefficients. In the linear trend case with large negative MA coefficients, the two tests perform very similarly. In all cases, the BT test is clearly dominated by the $\rho(0.1)$, and $\rho(\bar{c}, 0.1)$ tests.

It is clear that the application of the sieve bootstrap procedure described here reduces the size distortion in small samples, and in fact delivers tests with size properties that are as good as those of the ADF-GLS tests with MAIC lag selection. Furthermore, in terms of power, the bootstrapped $\rho(\bar{c}, 0.1)$ test is clearly superior to existing tuning parameter free tests (here the BT test), and is generally at least as powerful as, and in some cases even superior to, the ADF-GLS test.

5 Concluding Remarks

The family of nonparametric variance ratio tests of the unit root hypothesis presented here has the property that the tests are free of tuning parameters. That is, there are no parameters involved in calculating the test which are not reflected in the asymptotic distribution. The tests are constructed as a ratio of the sample variance of the observed series and that of a fractional partial sum of the series, possibly applying GLS detrending to handle deterministic terms, and the family is thus indexed by the parameter d which determines the order of the fractional partial summation. However, unlike the choice of tuning parameters, e.g., lag length in augmented Dickey-Fuller regressions or bandwidth in Phillips-Perron type tests, each member of the family with d > 0 is consistent and its asymptotic distribution depends on d, thus reflecting the parameter chosen to implement the test. Consequently, using local-to-unity asymptotics, the power of each member of the family against near-integrated alternatives was derived. In particular, it was shown that members of the family with d < 1 have asymptotic local power that is better than that of Breitung's (2002) test;

a leading tuning parameter free test. Furthermore, when d is small the asymptotic local power of the proposed test is relatively close to the parametric power envelope, especially in the case with a linear time trend.

Simulation evidence demonstrates the finite sample properties of the proposed test. In the case of ARMA type short-run dynamics, the variance ratio test may suffer from size distortion in small samples (e.g., T = 100), as does Breitung's (2002) test, although this is alleviated in larger samples (such as T = 500). When considering size-adjusted finite sample power, the proposed test with d < 1 is clearly superior to existing tuning parameter free tests, specifically Breitung's (2002) test, and moreover it is similar, and sometimes superior, to the GLS detrended ADF test when the two are compared on an even footing by applying the MAIC to select the lag augmentation of the Dickey-Fuller regressions. In the case of nonlinear short-run dynamics or underlying errors that are fractionally integrated, the nonparametric nature of the variance ratio test and its asymptotic invariance to short-run dynamics is particularly attractive, resulting in finite-sample size-adjusted powers that are superior to those of the other tests in the comparison. To alleviate the size distortion, a sieve bootstrap procedure is applied to the proposed variance ratio test in a separate set of simulations. The test then has size properties that are as good as those of the ADF-GLS test using the MAIC lag selection rule, even in the presence of moving average errors with large negative coefficients. With the sieve bootstrap procedure, the finite sample power of the variance ratio test is similar to that of the ADF-GLS test and even superior in some cases, such as the important case of a model that includes a linear time trend and has moving average errors.

Appendix: Proofs

Proof of Theorem 1. In the case with no deterministic terms the result follows immediately by the continuous mapping theorem since (4) and (5) hold under Assumption 1. In the presence of deterministic terms, recall that $\hat{y}_t = z_t - (\hat{\alpha} - \alpha)' \delta_t$, where z_t is generated as y_t in (1). From (4) the convergence

$$T^{-1/2}z_{\lfloor Ts \rfloor} \Rightarrow \sigma_y W_0\left(s\right)$$

holds. Now define $N_1(T) = 1$ and $N_2(T) = diag(1, T^{-1})$ and write

$$T^{-1/2} \left(\hat{\alpha} - \alpha \right)' \delta_{\lfloor Ts \rfloor} = \left(T^{-1} \sum_{s=1}^{T} T^{-1/2} z_s \delta'_s N_j(T) \right) \left(T^{-1} \sum_{s=1}^{T} N_j(T) \delta_s \delta'_s N_j(T) \right)^{-1} N_j(T) \delta_{\lfloor Ts \rfloor},$$

where

$$T^{-1/2} (\hat{\alpha} - \alpha)' N_j(T)^{-1} = \left(T^{-1} \sum_{s=1}^T T^{-1/2} z_s \delta'_s N_j(T) \right) \left(T^{-1} \sum_{s=1}^T N_j(T) \delta_s \delta'_s N_j(T) \right)^{-1}$$
(27)
$$= \left(T^{-1} \sum_{s=1}^T T^{-1/2} z_s D_j(s/T) \right) \left(T^{-1} \sum_{s=1}^T D_j(s/T) D_j(s/T)' \right)^{-1}$$
$$\Rightarrow \sigma_y \left(\int_0^1 W_0(s) D_j(s)' ds \right) \left(\int_0^1 D_j(s) D_j(s)' ds \right)^{-1}$$

by application of (4) and the continuous mapping theorem, and

$$N_j(T)\delta_{\lfloor Ts \rfloor} = D_j(\lfloor Ts \rfloor/T) \to D_j(s) \text{ as } T \to \infty.$$
(28)

It thus follows that

$$\hat{y}_T(s) = T^{-1/2} \hat{y}_{\lfloor Ts \rfloor} \Rightarrow \sigma_y B_j(s), \quad j = 0, 1, 2.$$
⁽²⁹⁾

Next, for $\tilde{y}_T(s) = T^{-d} \Delta_+^{-d} \hat{y}_T(s) = T^{-1/2-d} \sum_{k=0}^{\lfloor Ts \rfloor - 1} \pi_k(d) \hat{y}_{\lfloor Ts \rfloor - k} = T^{-1/2-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k}(d) \hat{y}_k$, where $\hat{y}_t = z_t - (\hat{\alpha} - \alpha)' \delta_t$ and $\pi_k(d) = \Gamma(k+d) / (\Gamma(d)\Gamma(k+1))$, the convergence

$$T^{-1/2-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} \left(d \right) z_k \Rightarrow \sigma_y W_d(s)$$

holds from (5). For the remaining term, i.e.,

$$T^{-1/2-d}\sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} \left(d \right) \left(\hat{\alpha} - \alpha \right)' \delta_k = \left(T^{-1/2} \left(\hat{\alpha} - \alpha \right)' N_j(T)^{-1} \right) \left(T^{-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} \left(d \right) N_j(T) \delta_k \right),$$

the first factor converges by (27) and the last factor is deterministic and satisfies the convergence

$$T^{-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} (d) N_j(T) \delta_k = T^{-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} (d) D_j(k/T)$$

$$= T^{-d} \sum_{k=1}^{\lfloor Ts \rfloor} \frac{(\lfloor Ts \rfloor - k)^{d-1}}{\Gamma(d)} D_j(k/T) + o(1)$$

$$= T^{-1} \sum_{k=1}^{\lfloor Ts \rfloor} \frac{\left(\lfloor Ts \rfloor - k \right)^{d-1}}{\Gamma(d)} D_j(k/T) + o(1)$$

$$\to \int_0^s \frac{(s-r)^{d-1}}{\Gamma(d)} D_j(r) dr \text{ as } T \to \infty.$$
(30)

Hence, it follows that

$$\tilde{y}_{T}(s) \Rightarrow \sigma_{y} \tilde{B}_{j,d}(s), \quad j = 0, 1, 2,$$

which proves the desired result. \blacksquare

Proof of Theorem 2. The test has asymptotic size γ by Theorem 1 and the definition of $CV_{j,\gamma}(d)$. Consistency is proved in the case $\delta_t = 0$; the remaining cases follow similarly. Under the alternative hypothesis H₁ in (2) and Assumption 1, y_t is stationary and ergodic such that $\omega_y^2 = Ey_t^2 < \infty$, and

$$T^{-1}\sum_{t=1}^T y_t^2 \xrightarrow{P} \omega_y^2$$

by the law of large numbers for stationary ergodic time series, e.g. White (1984, p. 42).

Under H₁ and Assumption 1 it also holds that $0 < \sum_{k=-\infty}^{\infty} |\gamma_y(k)| < \infty$, where $\gamma_y(k) = E(y_t y_{t+k})$. If d < 1/2 note that

$$Var(\tilde{y}_t) = \sum_{m=0}^{t-1} \sum_{k=0}^{t-1} \pi_m(d) \pi_k(d) \gamma_y(m-k) \le C \sum_{m=0}^{t-1} |\gamma_y(m)| \sum_{k=0}^{t-1-m} (k+m)^{d-1} k^{d-1} \le C \sum_{m=0}^{\infty} |\gamma_y(m)| < \infty$$

Here, and throughout, C > 0 denotes a generic constant which may take different values in different places. If d > 1/2,

$$T^{1-2d}Var(\tilde{y}_t) \le CT^{1-2d} \sum_{m=0}^{t-1} |\gamma_y(m)| \sum_{k=0}^{t-1-m} (k+m)^{d-1} k^{d-1}.$$

The evaluations $(k+m)^{d-1}k^{d-1} \leq k^{2d-2}$ if d < 1 and $(k+m)^{d-1}k^{d-1} \leq T^{2d-2}$ if $d \geq 1$ then give

$$T^{1-2d}Var(\tilde{y}_t) \le C \sum_{m=0}^{\infty} |\gamma_y(m)| \begin{cases} T^{-1} \sum_{k=0}^{T} (k/T)^{2d-2} \to \int_0^1 x^{2d-2} dx < \infty, & d < 1, \\ T^{1-2d} \sum_{k=0}^{T} T^{2d-2} < \infty, & d \ge 1. \end{cases}$$

Hence, under H₁ and Assumption 1, $\rho(d)^{-1} = O_P(T^{-\min(1,2d)})$ and thus $\rho(d)$ diverges in probability to $+\infty$ when d > 0, noting that $\rho(d) > 0$ by construction. Consistency against the alternative H₁ follows.

Proof of Theorem 3. Recall that $\hat{y}_t = z_t - (\hat{\alpha} - \alpha)' \delta_t$, where z_t is generated by (13). Under assumptions implied by Assumption 1, Chan & Wei (1987) and Phillips (1987b) proved that

$$T^{-1/2}z_{\lfloor Ts \rfloor} \Rightarrow \sigma_y J_{0,c}\left(s\right),\tag{31}$$

where $J_{0,c}(s) = W(s) - c \int_0^s e^{-c(s-r)} W(r) dr$, $J_{0,c}(0) = 0$, is the Ornstein-Uhlenbeck process which is sometimes also written as $J_{0,c}(s) = \int_0^s e^{-c(s-r)} dW_0(r)$. As in (27) it follows that

$$T^{-1/2} \left(\hat{\alpha} - \alpha\right)' N_j(T)^{-1} \Rightarrow \sigma_y \left(\int_0^1 J_{0,c}(r) D_j(r)' dr \right) \left(\int_0^1 D_j(r) D_j(r)' dr \right)^{-1}, \qquad (32)$$

which combined with (28) and (31) implies that

$$\hat{y}_T(s) = T^{-1/2} \hat{y}_{\lfloor Ts \rfloor} \Rightarrow \sigma_y J_{j,c}(s) , \qquad (33)$$

where $J_{j,c}(s)$ is the demeaned (j = 1) or detrended (j = 2) Ornstein-Uhlenbeck process defined in Theorem 3.

As in the proof of Theorem 1, define $\hat{y}_T(s) = T^{-d} \Delta_+^{-d} \hat{y}_T(s) = T^{-1/2-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k}(d) \hat{y}_k$. First suppose there are no deterministic terms (j = 0), in which case $\hat{y}_t = y_t$. Since $e^{-c/T} = 1 - c/T + O(T^{-2})$ it follows that $y_t = \sum_{k=1}^t e^{-c(t-k)/T} u_k$ (where a negligible remainder term has been left out), and using summation by parts the representation

$$y_t = \sum_{k=1}^t e^{-c(t-k)/T} u_k = \sum_{k=1}^t u_k + \sum_{k=1}^{t-1} \left(e^{-c(t-k)/T} - e^{-c(t-k-1)/T} \right) \sum_{m=1}^k u_m$$

is obtained. By the mean value theorem, for $0 \le x \le 1$,

$$e^{-c(t-k-1)/T} = e^{-c(t-k)/T} + \frac{c}{T}e^{-c(t-k)/T} + \frac{1}{2}\left(\frac{c}{T}\right)^2 e^{-c(t-k-x)/T}$$
$$= e^{-c(t-k)/T} + \frac{c}{T}e^{-c(t-k)/T}\left(1 + O\left(T^{-1}\right)\right),$$

which implies that

$$y_t = \sum_{k=1}^t u_k - \frac{c}{T} \sum_{k=1}^{t-1} e^{-c(t-k)/T} \sum_{m=1}^k u_m \left(1 + O_P \left(T^{-1} \right) \right).$$

The $O_P(T^{-1})$ term is uniform in t and is therefore ignored in the following.

Now, still in the case with no deterministic terms, $\tilde{y}_T(s) = T^{-1/2-d} \sum_{k=1}^{\lfloor T_s \rfloor} \pi_{\lfloor T_s \rfloor - k}(d) y_k$ is

$$\tilde{y}_T(s) = T^{-1/2-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} (d) \sum_{m=1}^k u_m - T^{-1/2-d} \sum_{k=2}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} (d) \frac{c}{T} \sum_{m=1}^{k-1} e^{-c(k-m)/T} \sum_{l=1}^m u_l = \tilde{y}_{1T}(s) - \tilde{y}_{2T}(s),$$

where $\tilde{y}_{1T}(s) = T^{-1/2-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k}(d) \sum_{m=1}^{k} u_m \Rightarrow \sigma_y W_d(s)$ by (5). By interchanging the order of the summations the second term can be rearranged as

$$\sum_{k=2}^{t} \pi_{t-k} (d) \frac{c}{T} \sum_{m=1}^{k-1} e^{-c(k-m)/T} \sum_{l=1}^{m} u_l = \frac{c}{T} \sum_{m=0}^{t-2} e^{-c(m+1)/T} \sum_{k=2}^{t-m} \pi_{t-m-k} (d) \sum_{l=1}^{k-1} u_l$$
$$= \frac{c}{T} \sum_{m=1}^{t-1} e^{-c(t-m)/T} \sum_{k=1}^{m} \pi_{m-k} (d) \sum_{l=1}^{k} u_l,$$

and thus $\tilde{y}_{2T}(s)$ is

$$\tilde{y}_{2T}(s) = \frac{c}{T} \sum_{k=1}^{\lfloor Ts \rfloor - 1} e^{-c(\lfloor Ts \rfloor - k)/T} \tilde{y}_{1T}(k/T)$$

$$= c \sum_{k=1}^{\lfloor Ts \rfloor - 1} e^{-c(\lfloor Ts \rfloor - k)/T} \int_{k/T}^{(k+1)/T} \tilde{y}_{1T}(r) dr$$

$$= c \sum_{k=1}^{\lfloor Ts \rfloor - 1} \int_{k/T}^{(k+1)/T} e^{-c(\lfloor Ts \rfloor - \lfloor Tr \rfloor)/T} \tilde{y}_{1T}(r) dr$$

$$= c \int_{1/T}^{\lfloor Ts \rfloor/T} e^{-c(\lfloor Ts \rfloor - \lfloor Tr \rfloor)/T} \tilde{y}_{1T}(r) dr$$

$$= c \int_{0}^{s} e^{-c(s-r)} \tilde{y}_{1T}(r) dr + R_{T}(s).$$

By application of (5) and the continuous mapping theorem (since the functional $\int_0^s e^{-c(s-r)} f(r) dr$ is a continuous mapping from D[0, 1] to D[0, 1]) it follows that

$$c\int_0^s e^{-c(s-r)}\tilde{y}_{1T}(r)dr \Rightarrow \sigma_y c\int_0^s e^{-c(s-r)}W_d(r)\,dr.$$

Thus, it only remains to show that the approximation error $R_T(s)$ is asymptotically negligible uniformly in $s \in [0, 1]$. Write $R_T(s)$ as

$$R_T(s) = c \int_0^{1/T} e^{-c(\lfloor Ts \rfloor - \lfloor Tr \rfloor)/T} \tilde{y}_{1T}(r) dr + c \int_{\lfloor Ts \rfloor/T}^s e^{-c(\lfloor Ts \rfloor - \lfloor Tr \rfloor)/T} \tilde{y}_{1T}(r) dr + c \int_0^s \left(e^{-c(\lfloor Ts \rfloor - \lfloor Tr \rfloor)/T} - e^{-c(s-r)} \right) \tilde{y}_{1T}(r) dr.$$

It is easily seen that $\int_0^{1/T} e^{-c(\lfloor Ts \rfloor - \lfloor Tr \rfloor)/T} \tilde{y}_{1T}(r) dr = 0$ because $\tilde{y}_{1T}(r) = 0$ for r < 1/T. For the next term we have that

$$\sup_{0 \le s \le 1} c \int_{\lfloor Ts \rfloor/T}^{s} e^{-c(\lfloor Ts \rfloor - \lfloor Tr \rfloor)/T} \tilde{y}_{1T}(r) dr \le \sup_{0 \le s \le 1} C \int_{\lfloor Ts \rfloor/T}^{s} \tilde{y}_{1T}(r) dr$$
$$\le \sup_{0 \le s \le 1} C \left(\frac{Ts - \lfloor Ts \rfloor}{T}\right) \left| \tilde{y}_{1T} \left(\frac{\lfloor Ts \rfloor}{T}\right) \right|$$
$$\le \frac{C}{T} \sup_{0 \le s \le 1} \left| \tilde{y}_{1T} \left(s \right) \right|,$$

which is $O_P(T^{-1})$ since $\sup_{0 \le s \le 1} |\tilde{y}_{1T}(s)| \Rightarrow \sigma_y \sup_{0 \le s \le 1} |W_d(s)|$ by (5) and the continuous map-

ping theorem. The last term of $R_T(s)$ is bounded by

$$\begin{split} \sup_{0 \le s \le 1} c \int_0^s \left(e^{-c(\lfloor Ts \rfloor - \lfloor Tr \rfloor)/T} - e^{-c(s-r)} \right) \tilde{y}_{1T}(r) dr \\ \le \sup_{0 \le s \le 1} c \int_0^s \left(e^{-c(\lfloor Ts \rfloor/T - \lfloor Tr \rfloor/T)} - e^{-c(\lfloor Ts \rfloor/T - r)} \right) \tilde{y}_{1T}(r) dr \\ + \sup_{0 \le s \le 1} c \int_0^s \left(e^{-c(\lfloor Ts \rfloor/T - r)} - e^{-c(s-r)} \right) \tilde{y}_{1T}(r) dr \\ \le \sup_{0 \le r \le 1} C \left| \left(e^{c(\lfloor Tr \rfloor/T)} - e^{cr} \right) \tilde{y}_{1T}(r) \right| + \sup_{0 \le r \le 1} \frac{C}{T} e^{cr} \left| \tilde{y}_{1T}(r) \right| \\ \le \frac{C}{T} \sup_{0 \le r \le 1} \left| \tilde{y}_{1T}(r) \right|, \end{split}$$

which is $O_P(T^{-1})$ by (5) and the continuous mapping theorem. Hence $\sup_{0 \le s \le 1} R_T(s) \xrightarrow{P} 0$.

Finally, the result for the fractional partial sum of the detrended process, i.e. the result for $\tilde{y}_T(s) = T^{-1/2-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k}(d) \hat{y}_k$, can easily be proven. Writing $\hat{y}_t = z_t - (\hat{\alpha} - \alpha)' \delta_t$, where z_t is generated by (13), it has already been shown that

$$T^{-1/2-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} \left(d \right) z_k \Rightarrow \sigma_y \tilde{J}_{0,c,d} \left(s \right), \tag{34}$$

and it only remains to combine this result with (30) and (32) to get

$$\tilde{y}_{T}(s) \Rightarrow \sigma_{y}\tilde{J}_{0,c,d}(s) - \sigma_{y}\left(\int_{0}^{1} J_{0,c}(r) D_{j}(r)' dr\right) \left(\int_{0}^{1} D_{j}(r) D_{j}(r)' dr\right)^{-1} \int_{0}^{s} \frac{(s-r)^{d-1}}{\Gamma(d)} D_{j}(r) dr.$$

Proof of Theorem 4. From Elliott et al. (1996, pp. 834-835) it follows that $T^{-1/2}\hat{y}_{\bar{c},\lfloor Ts \rfloor} \Rightarrow \sigma_y J_{0,c}(s)$ if j = 1 and $T^{-1/2}\hat{y}_{\bar{c},\lfloor Ts \rfloor} \Rightarrow \sigma_y V_{\bar{c},c}(s)$ if j = 2. Now $\tilde{y}_{\bar{c},t}$ is based on

$$\hat{y}_{\bar{c},t} = z_t - (\tilde{\alpha}_0 - \alpha_0) - (\tilde{\alpha}_1 - \alpha_1)t, \qquad (35)$$

which is GLS detrended as in (15). Note that (35) applies to the case j = 2; when j = 1 the last term is not present. From Elliott et al. (1996, p. 835) it is known that $\tilde{\alpha}_0 = O_P(1)$ and

$$\sqrt{T}(\tilde{\alpha}_1 - \alpha_1) \Rightarrow \sigma_y \frac{(1 + \bar{c})}{1 + \bar{c} + \bar{c}^2/3} J_{0,c}(1) + \sigma_y \frac{\bar{c}^2}{1 + \bar{c} + \bar{c}^2/3} \int_0^1 r J_{0,c}(r) \, dr = \sigma_y b_1. \tag{36}$$

It follows immediately that $T^{-1/2-d}\tilde{y}_{\bar{c},\lfloor T_s \rfloor} \Rightarrow \sigma_y \tilde{J}_{0,c,d}(s)$ for j=1 when $\tilde{y}_{\bar{c},t}$ is based on $\hat{y}_{\bar{c},t}$.

It only remains to be shown that $T^{-1/2-d}\tilde{y}_{\bar{c},\lfloor Ts\rfloor} \Rightarrow \sigma_y \tilde{V}_{\bar{c},c,d}(s)$ when j = 2. Following the steps in the proofs of Theorems 1 and 3, write

$$T^{-1/2-d}\tilde{y}_{\bar{c},\lfloor Ts\rfloor} = T^{-1/2-d} \sum_{k=1}^{\lfloor Ts\rfloor} \pi_{\lfloor Ts\rfloor-k} \left(d\right) \hat{y}_{\bar{c},k}$$

and use (35) to obtain the representation

$$T^{-1/2-d}\tilde{y}_{\bar{c},\lfloor Ts\rfloor} = T^{-1/2-d} \sum_{k=1}^{\lfloor Ts\rfloor} \pi_{\lfloor Ts\rfloor-k} \left(d\right) z_k \tag{37}$$

$$-\left(\tilde{\alpha}_{0}-\alpha_{0}\right)T^{-1/2-d}\sum_{k=1}^{\lfloor Ts \rfloor}\pi_{\lfloor Ts \rfloor-k}\left(d\right)$$
(38)

$$-\sqrt{T}(\tilde{\alpha}_1 - \alpha_1)T^{-d}\sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k}(d) \frac{\lfloor Ts \rfloor}{T}.$$
(39)

It has already been shown in (34) that (37) converges weakly to $\sigma_y \tilde{J}_{0,c,d}(s)$. Next,

$$\sup_{0 \le s \le 1} T^{-1/2-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} (d) = \sup_{0 \le s \le 1} T^{-1/2-d} \sum_{k=0}^{\lfloor Ts \rfloor - 1} \pi_k (d)$$
$$\leq C \sup_{0 \le s \le 1} T^{-1/2-d} \sum_{k=1}^{\lfloor Ts \rfloor - 1} k^{d-1}$$
$$\leq CT^{-1/2},$$

and since $\tilde{\alpha}_0 = O_P(1)$ this implies that (38) is $O_P(T^{-1/2})$. For (39) use (36) and

$$T^{-d} \sum_{k=1}^{\lfloor Ts \rfloor} \pi_{\lfloor Ts \rfloor - k} \left(d \right) \frac{\lfloor Ts \rfloor}{T} \to \frac{s^{d+1}}{\Gamma \left(d + 2 \right)},$$

such that, for j = 2, $T^{-1/2-d}\tilde{y}_{\bar{c},\lfloor Ts \rfloor} \Rightarrow \sigma_y \tilde{J}_{0,c,d}(s) - \sigma_y b_1 \frac{s^{d+1}}{\Gamma(d+2)} = \sigma_y \tilde{V}_{\bar{c},c,d}(s).$

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Deterministics	γ	T	d = 0.10	d = 0.25	d = 0.50	d = 0.75	d = 1.00	
$j = 0 : \delta_t = 0$	0.10	100	1.54	2.78	6.76	15.30	33.63	
		500	1.54	2.77	6.70	15.09	33.13	
	0.05	100	1.62	3.13	8.45	21.00	48.73	
		500	1.62	3.14	8.44	20.70	49.42	
	0.01	100	1.76	3.90	12.55	36.12	98.82	
		500	1.77	3.92	12.93	38.59	106.6	
$j = 1 : \delta_t = 1$	0.10	100	1.75	3.83	12.29	32.04	70.03	
		500	1.76	3.87	12.39	32.32	70.43	
	0.05	100	1.81	4.18	14.49	41.55	100.4	
		500	1.82	4.20	14.43	40.83	97.83	
	0.01	100	1.92	4.82	19.39	64.82	186.3	
		500	1.93	4.85	18.98	62.12	173.1	
$j = 2 : \delta_t = [1, t]'$	0.10	100	1.91	4.78	19.50	69.86	227.4	
		500	1.92	4.83	19.68	70.35	228.0	
	0.05	100	1.96	5.09	22.07	83.94	291.3	
		500	1.98	5.17	22.33	84.79	289.6	
	0.01	100	2.04	5.68	27.73	119.1	455.1	
		500	2.08	5.83	28.26	118.8	446.2	

Table 1: Critical values $CV_{j,\gamma}(d)$ of the variance ratio test (10)

Note: The critical values are simulated based on 20,000 Monte Carlo replications. The test rejects when the test statistic is larger than the critical values in this table.

Table 2: Values of c and $CV_{j,\gamma}(c,d)$ of the VR-GLS test (16)										
Deterministics	γ	T	d = 0.10	d = 0.25	d = 0.50	d = 0.75	d = 1.00			
Panel A: Values of $\bar{c} = c$ that yield asymptotic local power of 50%										
$j = 1 : \delta_t = 1$		500	9.4	10.6	12.8	16.3	20.8			
$j = 2 : \delta_t = [1, t]'$	0.05	500	15.1	16.1	18.7	22.5	28.0			
Panel B: Critical values $CV_{j,\gamma}(\bar{c},d)$										
$j = 2 : \delta_t = [1, t]'$	0.10	100	1.80	4.05	13.72	41.75	122.9			
		500	1.77	3.86	11.92	31.84	78.21			
	0.05	100	1.85	4.37	15.98	52.28	161.5			
		500	1.83	4.19	14.05	40.62	108.1			
	0.01	100	1.95	5.01	20.97	76.37	267.7			
		500	1.95	4.89	19.29	65.16	195.2			

J) VD CIC+ +(16) $T \sim 1.1$ (-C + 1 0 **X**Za 1 OT Z

Note: The values of $\bar{c} = c$ in Panel A of the table correspond to the (local) point alternatives against which the local asymptotic power for significance level 5% equals one-half. The critical values in Panel B apply the corresponding value of \bar{c} from Panel A. The results are simulated based on 20,000 Monte Carlo replications. The test rejects when the test statistic is larger than the critical values in Panel B of this table.

$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$		Test			MA				AR					
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	ϕ	Statistic	-0.5	-0.3	0.0	0.3	0.5	-0.5	-0.3	0.3	0.5			
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	1.00	$\rho(0.1)$	0.21	0.10	0.05	0.03	0.03	0.12	0.08	0.03	0.02			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		$ ho\left(ar{c},0.1 ight)$	0.23	0.15	0.10	0.09	0.08	0.16	0.13	0.08	0.06			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		BT	0.09	0.06	0.05	0.04	0.04	0.06	0.05	0.04	0.04			
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$		ADF	0.06	0.05	0.04	0.04	0.04	0.04	0.04	0.03	0.04			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		ADF-GLS	0.07	0.06	0.05	0.04	0.04	0.05	0.05	0.04	0.05			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$														
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	0.9	$ ho\left(0.1 ight)$	0.45	0.43	0.40	0.37	0.37	0.44	0.42	0.36	0.34			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$														
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$										0.30				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$						0.13			0.21	0.11	0.17			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		ADF-GLS	0.52	0.56	0.65	0.57	0.56	0.61	0.60	0.54	0.54			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$														
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	0.8													
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$														
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$								0.63	0.60	0.53	0.49			
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$														
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		ADF-GLS	0.74	0.79	0.86	0.87	0.83	0.82	0.83	0.87	0.76			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$														
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	0.7													
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$														
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$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$														
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$		ADF-GLS	0.81	0.83	0.88	0.91	0.89	0.85	0.86	0.92	0.86			
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$														
BT0.960.910.840.810.800.930.890.790.72ADF0.650.660.730.800.730.680.680.820.55	0.6													
ADF 0.65 0.66 0.73 0.80 0.73 0.68 0.68 0.82 0.55														
ADF-GLS 0.85 0.85 0.88 0.92 0.90 0.87 0.87 0.93 0.91														
		ADF-GLS	0.85	0.85	0.88	0.92	0.90	0.87	0.87	0.93	0.91			

Table 3: Size and Size-Adjusted Power: Constant Mean, T = 100

	Test			MA			AR					
ϕ	Statistic	-0.5	-0.3	0.0	0.3	0.5	-0.5	-0.3	0.3	0.5		
1.00	$ ho\left(0.1 ight)$	0.35	0.14	0.05	0.03	0.02	0.18	0.11	0.02	0.01		
	$ ho\left(ar{c},0.1 ight)$	0.30	0.13	0.05	0.03	0.03	0.16	0.10	0.03	0.01		
	BT	0.15	0.08	0.05	0.04	0.04	0.08	0.07	0.04	0.03		
	ADF	0.09	0.06	0.04	0.03	0.04	0.04	0.05	0.03	0.04		
	ADF-GLS	0.08	0.06	0.04	0.02	0.03	0.04	0.05	0.02	0.04		
0.9	$ ho\left(0.1 ight)$	0.23	0.23	0.21	0.20	0.20	0.23	0.22	0.19	0.18		
	$ ho\left(ar{c},0.1 ight)$	0.31	0.30	0.28	0.27	0.27	0.29	0.29	0.26	0.25		
	BT	0.20	0.19	0.18	0.18	0.18	0.20	0.19	0.18	0.17		
	ADF	0.13	0.14	0.16	0.08	0.09	0.14	0.14	0.08	0.10		
	ADF-GLS	0.21	0.23	0.28	0.22	0.21	0.26	0.25	0.18	0.19		
0.8	$ ho\left(0.1 ight)$	0.71	0.68	0.61	0.57	0.55	0.69	0.66	0.55	0.48		
	$ ho\left(ar{c},0.1 ight)$	0.85	0.82	0.76	0.73	0.71	0.82	0.80	0.71	0.64		
	BT	0.54	0.50	0.45	0.42	0.42	0.51	0.48	0.41	0.38		
	ADF	0.33	0.36	0.47	0.27	0.19	0.41	0.40	0.19	0.15		
	ADF-GLS	0.47	0.53	0.67	0.62	0.47	0.61	0.60	0.52	0.30		
0.7	$ ho\left(0.1 ight)$	0.97	0.95	0.91	0.86	0.85	0.96	0.94	0.84	0.76		
	$ ho\left(ar{c},0.1 ight)$	0.99	0.99	0.97	0.95	0.94	0.99	0.98	0.94	0.89		
	BT	0.82	0.76	0.68	0.64	0.63	0.78	0.74	0.62	0.57		
	ADF	0.51	0.54	0.68	0.63	0.39	0.61	0.60	0.53	0.12		
	ADF-GLS	0.63	0.67	0.78	0.85	0.73	0.72	0.73	0.84	0.34		
0.6	$ ho\left(0.1 ight)$	1.00	1.00	0.99	0.97	0.96	1.00	1.00	0.96	0.91		
	$ ho\left(ar{c},0.1 ight)$	1.00	1.00	1.00	0.99	0.99	1.00	1.00	0.99	0.97		
	BT	0.95	0.91	0.83	0.79	0.77	0.92	0.89	0.76	0.70		
	ADF	0.64	0.63	0.73	0.81	0.65	0.67	0.67	0.80	0.25		
	ADF-GLS	0.72	0.73	0.80	0.88	0.83	0.76	0.76	0.90	0.62		

Table 4: Size and Size-Adjusted Power: Linear Trend, $T=100\,$

	Test			MA				AR						
ϕ	Statistic	-0.5	-0.3	0.0	0.3	0.5	-0.5	-0.3	0.3	0.5				
1.00	$\rho(0.1)$	0.10	0.07	0.05	0.05	0.04	0.07	0.06	0.04	0.04				
	$ ho\left(ar{c},0.1 ight)$	0.08	0.07	0.06	0.06	0.06	0.07	0.06	0.05	0.05				
	BT	0.06	0.05	0.05	0.05	0.05	0.05	0.05	0.05	0.05				
	ADF	0.05	0.04	0.04	0.04	0.04	0.04	0.04	0.04	0.04				
	ADF-GLS	0.05	0.05	0.04	0.04	0.04	0.04	0.04	0.04	0.04				
0.00	(0,1)	0.40	0.00	0.00	0.07	0.07	0.40	0.00	0.07	0.96				
0.98	$\rho(0.1)$	0.42	0.39	0.38	0.37	0.37	0.40	0.38	0.37	0.36				
	$\rho\left(\bar{c}, 0.1\right)$	0.59	0.55	0.53	0.53	0.53	0.56	0.55	0.52	0.51				
	BT	0.31	0.30	0.29	0.29	0.29	0.30	0.30	0.29	0.29				
	ADF	0.26	0.26	0.27	0.25	0.23	0.26	0.26	0.25	0.25				
	ADF-GLS	0.71	0.72	0.74	0.71	0.71	0.74	0.74	0.72	0.71				
0.96	$\rho(0.1)$	0.87	0.83	0.80	0.79	0.79	0.84	0.82	0.78	0.76				
	$\rho(\bar{c}, 0.1)$	0.95	0.93	0.91	0.90	0.90	0.93	0.92	0.89	0.88				
	BT	0.57	0.55	0.53	0.53	0.53	0.55	0.54	0.52	0.52				
	ADF	0.68	0.72	0.76	0.71	0.67	0.75	0.75	0.73	0.71				
	ADF-GLS	0.97	0.98	0.98	0.98	0.98	0.98	0.98	0.98	0.98				
0.04	(0,1)	0.00	0.00	0.00	0.00	0.00	0.00	0.07	0.00	0.04				
0.94	$\rho(0.1)$	0.99	0.98	0.96	0.96	0.96	0.98	0.97	0.96	0.94				
	$\rho\left(\bar{c}, 0.1\right)$	1.00	0.99	0.99	0.98	0.98	0.99	0.99	0.98	0.98				
	BT	0.75	0.71	0.69	0.68	0.68	0.71	0.70	0.68	0.67				
	ADF	0.89	0.91	0.94	0.92	0.90	0.93	0.93	0.92	0.91				
	ADF-GLS	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00				
0.92	$ ho\left(0.1 ight)$	1.00	1.00	0.99	0.99	0.99	1.00	1.00	0.99	0.99				
	$\rho(\bar{c}, 0.1)$	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00				
	BT	0.85	0.81	0.79	0.78	0.78	0.82	0.80	0.78	0.76				
	ADF	0.95	0.96	0.97	0.96	0.96	0.97	0.97	0.96	0.96				
	ADF-GLS	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00				

Table 5: Size and Size-Adjusted Power: Constant Mean, T = 500

$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	0.5
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	0.03
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	0.04
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	0.04
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	0.04
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	0.03
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	0.19
$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	0.25
ADF-GLS 0.28 0.29 0.28 0.28 0.29 0.29 0.28 0 0.96 ρ (0.1) 0.65 0.61 0.57 0.55 0.55 0.61 0.59 0.55 0	0.18
$0.96 ho (0.1) \qquad 0.65 0.61 0.57 0.55 0.55 0.61 0.59 0.55 0.55 0.61 0.59 0.55 $	0.16
	0.28
$ ho\left(ar{c},0.1 ight)=0.76$ 0.73 0.70 0.68 0.68 0.73 0.72 0.68 0	0.53
	0.66
	0.39
	0.48
	0.75
	0.82
	0.90
	0.59
	0.78
ADF-GLS 0.91 0.92 0.95 0.93 0.93 0.94 0.94 0.93 0	0.93
	0.95
	0.97
	0.72
	0.89
ADF-GLS 0.96 0.96 0.97 0.97 0.97 0.97 0.97 0.97 0.97 0	0.97

Table 6: Size and Size-Adjusted Power: Linear Trend, T = 500

	Test	GAI	RCH	Bil	lin	VC	M	r	ГAR	Fr	ac	ST	UR
ϕ	Statistic	0.65	0.85	-0.8	0.8	-0.8	0.8	0.5	0.8	-0.1	0.1	0.1	0.5
1.00	$\rho(0.1)$	0.06	0.05	0.06	0.05	0.01	0.07	0.03	0.05	0.11	0.02	0.05	0.04
	$ ho\left(ar{c},0.1 ight)$	0.08	0.07	0.05	0.05	0.03	0.02	0.03	0.05	0.11	0.02	0.06	0.05
	BT	0.05	0.05	0.05	0.04	0.02	0.05	0.04	0.05	0.08	0.03	0.04	0.05
	ADF	0.03	0.02	0.04	0.04	0.01	0.14	0.02	2 0.02	0.09	0.02	0.03	0.03
	ADF-GLS	0.05	0.05	0.04	0.04	0.02	0.01	0.02	2 0.02	0.11	0.01	0.07	0.04
0.9	$\rho(0.1)$	0.21	0.21	0.17	0.18	0.15	0.14	0.20	0.21	0.21	0.20	1.00	0.50
	$\rho(\bar{c}, 0.1)$	0.26	0.26	0.13	0.12	0.20	0.25	0.28	0.28	0.30	0.26	0.95	0.56
	BT	0.18	0.18	0.16	0.17	0.14	0.14	0.18	0.19	0.18	0.18	0.94	0.36
	ADF	0.18	0.20	0.16	0.15	0.08	0.01	0.12	2 0.10	0.16	0.13	0.81	0.44
	ADF-GLS	0.23	0.24	0.15	0.15	0.14	0.19	0.27	0.24	0.25	0.28	0.74	0.57
0.8	$ ho\left(0.1 ight)$	0.58	0.61	0.54	0.56	0.39	0.37	0.57	0.60	0.64	0.57	1.00	0.90
	$\rho(\bar{c}, 0.1)$	0.68	0.71	0.48	0.48	0.49	0.61	0.74		0.81	0.70	0.97	0.88
	BT	0.45	0.44	0.43	0.45	0.30	0.27	0.42		0.47	0.42	0.99	0.66
	ADF	0.45	0.51	0.41	0.40	0.20	0.01	0.42		0.45	0.43	0.83	0.72
	ADF-GLS	0.55	0.58	0.51	0.51	0.30	0.42	0.72		0.59	0.73	0.75	0.76
0.7	$\rho(0.1)$	0.86	0.90	0.85	0.86	0.63	0.63	0.87	0.89	0.93	0.86	1.00	0.99
	$\rho(\bar{c}, 0.1)$	0.92	0.94	0.84	0.84	0.72	0.85	0.96		0.98	0.94	0.97	0.94
	BT	0.68	0.68	0.67	0.69	0.45	0.40	0.64		0.73	0.63	0.99	0.81
	ADF	0.63	0.67	0.63	0.62	0.36	0.04	0.72	0.61	0.64	0.70	0.84	0.77
	ADF-GLS	0.70	0.72	0.74	0.73	0.48	0.62	0.86		0.73	0.84	0.75	0.79
0.6	$ ho\left(0.1 ight)$	0.97	0.98	0.96	0.97	0.80	0.82	0.98	3 0.98	1.00	0.97	1.00	1.00
0.0	$\rho(\bar{c}, 0.1)$	0.98	0.99	0.97	0.97	0.86	0.95	0.99		1.00	0.99	0.98	0.96
	BT	0.80	0.83	0.82	0.84	$0.00 \\ 0.57$	0.53	0.79		0.88	0.00	1.00	0.88
	ADF	0.70	0.72	0.75	0.74	0.50	0.10	0.80		0.72	0.75	0.85	0.79
	ADF-GLS	0.75	0.75	0.81	0.81	0.61	0.74	0.87		0.78	0.84	0.75	0.79

Table 7: Size and Size-Adjusted Power: Linear Trend, T = 100

	Test	GAI	RCH	Bil	lin	VC	CM	TA	AR		Fr	ac		ST	UR
ϕ	Statistic	0.65	0.85	-0.8	0.8	-0.8	0.8	 0.5	0.8	_	-0.1	0.1	0.	1	0.5
1.00	$\rho(0.1)$	0.06	0.05	0.05	0.05	0.03	0.16	0.04	0.05	C	.17	0.03	0.1	22	0.06
	$ ho\left(ar{c},0.1 ight)$	0.06	0.06	0.05	0.05	0.07	0.03	0.05	0.05	C	.10	0.02	0.3	32	0.06
	BT	0.05	0.05	0.05	0.04	0.05	0.10	0.05	0.05	C	.09	0.03	0.	16	0.06
	ADF	0.03	0.02	0.04	0.04	0.04	0.23	0.03	0.04	C	.12	0.01	0.	13	0.03
	ADF-GLS	0.04	0.04	0.03	0.03	0.07	0.03	0.03	0.03	C	.11	0.00	0.3	32	0.04
0.00	(0,1)	0.00	0.01	0.11	0.10	0.15	0.10	0.00	0.00	C	01	0.10	0.1		0.47
0.98	$\rho(0.1)$	0.20	0.21	0.11	0.12	0.15	0.12	0.20	0.20		.21	0.19	0.8		0.47
	$\rho\left(\bar{c}, 0.1\right)$	0.25	0.25	0.01	0.00	0.20	0.24	0.27	0.26		.28	0.23	0.8		0.55
	BT	0.19	0.18	0.09	0.09	0.14	0.12	0.18	0.17		.18	0.18	0.'		0.34
	ADF	0.16	0.19	0.26	0.25	0.13	0.02	0.15	0.15		.17	0.11	0.8		0.51
	ADF-GLS	0.25	0.27	0.01	0.01	0.18	0.23	0.29	0.29	C	.28	0.27	0.8	31	0.63
0.96	$ ho\left(0.1 ight)$	0.55	0.58	0.51	0.51	0.37	0.28	0.55	0.56	C	.61	0.53	1.0	00	0.93
	$\rho(\overline{c}, 0.1)$	0.65	0.67	0.02	0.02	0.49	0.54	0.69	0.68	C	.77	0.60	0.9	96	0.92
	BT	0.42	0.42	0.34	0.36	0.30	0.23	0.40	0.40	C	.44	0.38	0.9	99	0.69
	ADF	0.46	0.55	0.62	0.61	0.33	0.04	0.47	0.48	C	.47	0.36	0.9	97	0.92
	ADF-GLS	0.65	0.73	0.12	0.11	0.42	0.51	0.77	0.75	C	.69	0.77	0.9	90	0.95
0.04	(0,1)	0.04	0.00	0.05	0.05	0.00	0.40	0.05	0.00	C	01	0.01	1 /	0	1.00
0.94	$\rho(0.1)$	0.84	0.86	0.85	0.85	0.60	0.48	0.85	0.86		.91	0.81	1.0		1.00
	$ ho\left(ar{c},0.1 ight)$	0.90	0.91	0.09	0.09	0.71	0.75	0.92	0.92		.97	0.85	0.9		0.97
	BT	0.63	0.63	0.59	0.60	0.45	0.35	0.61	0.61		.67	0.56	1.0		0.86
	ADF	0.73	0.82	0.86	0.85	0.53	0.10	0.80	0.77		.73	0.73	0.9		0.96
	ADF-GLS	0.87	0.92	0.48	0.47	0.63	0.70	0.96	0.93	C	.87	0.97	0.9	<i>9</i> 0	0.97
0.92	$ ho\left(0.1 ight)$	0.96	0.97	0.97	0.97	0.76	0.67	0.97	0.97	C	.99	0.94	1.0	00	1.00
	$\rho(\bar{c}, 0.1)$	0.97	0.98	0.24	0.23	0.84	0.87	0.98	0.99	1	.00	0.95	0.9	95	0.98
	BT	0.77	0.77	0.75	0.77	0.57	0.45	0.75	0.75	C	.82	0.70	1.0	00	0.93
	ADF	0.86	0.91	0.93	0.93	0.68	0.18	0.93	0.89	C	.85	0.93	0.9	99	0.98
	ADF-GLS	0.94	0.96	0.77	0.76	0.76	0.80	0.98	0.97	C	.94	0.99	0.8	39	0.98

Table 8: Size and Size-Adjusted Power: Linear Trend, T = 500

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ϕ	Test statistic $\setminus a$	-0.8	-0.6	-0.4	-0.2	0.0	0.2	0.4	0.6	0.8
1.00	$ ho\left(0.1 ight)$	0.11	0.06	0.05	0.05	0.05	0.04	0.04	0.03	0.03
	$ ho\left(ar{c},0.1 ight)$	0.07	0.04	0.04	0.04	0.04	0.04	0.04	0.03	0.03
	BT	0.10	0.06	0.05	0.05	0.05	0.05	0.05	0.05	0.04
	ADF	0.09	0.04	0.03	0.02	0.02	0.01	0.01	0.01	0.01
	ADF-GLS	0.12	0.08	0.07	0.06	0.05	0.04	0.04	0.04	0.03
0.9	$ ho\left(0.1 ight)$	0.43	0.32	0.32	0.32	0.34	0.30	0.27	0.22	0.18
	$ ho\left(ar{c},0.1 ight)$	0.52	0.45	0.46	0.47	0.49	0.46	0.41	0.36	0.29
	BT	0.42	0.31	0.30	0.29	0.29	0.28	0.26	0.25	0.22
	ADF	0.37	0.24	0.21	0.21	0.19	0.09	0.10	0.10	0.07
	ADF-GLS	0.70	0.62	0.62	0.64	0.66	0.54	0.53	0.49	0.42
0.8	$ ho\left(0.1 ight)$	0.73	0.56	0.57	0.61	0.65	0.65	0.57	0.49	0.40
	$ ho\left(ar{c},0.1 ight)$	0.80	0.67	0.70	0.74	0.79	0.81	0.74	0.67	0.58
	BT	0.73	0.54	0.51	0.50	0.51	0.50	0.47	0.43	0.40
	ADF	0.70	0.48	0.47	0.50	0.56	0.42	0.28	0.28	0.21
	ADF-GLS	0.92	0.81	0.81	0.83	0.86	0.87	0.83	0.78	0.71
0.7	$ ho\left(0.1 ight)$	0.90	0.68	0.66	0.70	0.75	0.79	0.74	0.66	0.56
	$ ho\left(ar{c},0.1 ight)$	0.92	0.76	0.70	0.79	0.83	0.86	0.84	0.79	0.71
	BT	0.90	0.68	0.63	0.63	0.64	0.65	0.61	0.56	0.51
	ADF	0.89	0.63	0.60	0.62	0.69	0.72	0.58	0.48	0.38
	ADF-GLS	0.97	0.88	0.86	0.86	0.88	0.90	0.89	0.86	0.81
0.6	$ ho\left(0.1 ight)$	0.97	0.76	0.71	0.73	0.76	0.81	0.80	0.74	0.65
	$ ho\left(ar{c},0.1 ight)$	0.97	0.82	0.78	0.80	0.83	0.86	0.86	0.82	0.76
	BT	0.97	0.77	0.70	0.69	0.70	0.72	0.70	0.65	0.59
	ADF	0.96	0.73	0.65	0.67	0.71	0.77	0.74	0.64	0.51
	ADF-GLS	0.99	0.92	0.89	0.88	0.89	0.90	0.90	0.88	0.85

Table 9: Finite sample rejection frequencies: Constant Mean, T = 100

Notes: The ADF and ADF-GLS tests use the MAIC to determine the lag augmentation with $k_{\min} = 0$ and $k_{\max} = \lfloor 12(T/100)^{1/4} \rfloor$ as in Perron & Qu (2007). The BT, $\rho(0.1)$, and $\rho(\bar{c}, 0.1)$ tests use the sieve bootstrap with same lag length as the ADF and ADF-GLS tests. For each statistic, entries under the rows marked $\phi = 1.00$ are the finite sample rejection frequencies under the null, i.e. the size. All other entries are finite sample power. Based on 20,000 Monte Carlo replications.

ϕ	Test statistic $\setminus a$	-0.8	-0.6	-0.4	-0.2	0.0	0.2	0.4	0.6	0.8
1.00	$ ho\left(0.1 ight)$	0.17	0.07	0.05	0.05	0.04	0.03	0.03	0.02	0.02
	$ ho\left(ar{c},0.1 ight)$	0.16	0.08	0.07	0.07	0.07	0.06	0.06	0.04	0.03
	BT	0.17	0.07	0.05	0.05	0.05	0.04	0.04	0.04	0.03
	ADF	0.18	0.07	0.04	0.04	0.03	0.01	0.01	0.02	0.01
	ADF-GLS	0.19	0.09	0.07	0.06	0.04	0.02	0.02	0.02	0.02
0.9	$ ho\left(0.1 ight)$	0.42	0.21	0.18	0.18	0.18	0.14	0.11	0.09	0.06
	$ ho\left(ar{c},0.1 ight)$	0.49	0.30	0.29	0.31	0.33	0.30	0.25	0.20	0.15
	BT	0.42	0.22	0.18	0.17	0.17	0.16	0.14	0.13	0.11
	ADF	0.44	0.21	0.17	0.15	0.12	0.04	0.04	0.05	0.03
	ADF-GLS	0.52	0.32	0.28	0.27	0.25	0.12	0.11	0.12	0.09
0.8	$ ho\left(0.1 ight)$	0.74	0.45	0.41	0.43	0.48	0.44	0.35	0.26	0.19
	$ ho\left(ar{c},0.1 ight)$	0.79	0.57	0.57	0.62	0.68	0.69	0.60	0.49	0.38
	BT	0.75	0.46	0.41	0.39	0.40	0.38	0.34	0.29	0.25
	ADF	0.75	0.46	0.40	0.40	0.43	0.24	0.11	0.14	0.11
	ADF-GLS	0.81	0.58	0.57	0.59	0.65	0.51	0.34	0.34	0.27
0.7	$ ho\left(0.1 ight)$	0.92	0.62	0.57	0.60	0.67	0.71	0.61	0.46	0.35
	$\rho(\bar{c}, 0.1)$	0.93	0.71	0.68	0.72	0.78	0.83	0.79	0.68	0.56
	BT	0.92	0.65	0.57	0.56	0.58	0.58	0.54	0.46	0.39
	ADF	0.92	0.64	0.57	0.59	0.66	0.61	0.36	0.28	0.24
	ADF-GLS	0.94	0.73	0.69	0.72	0.77	0.80	0.68	0.57	0.48
0.6	$ ho\left(0.1 ight)$	0.98	0.75	0.65	0.66	0.72	0.79	0.76	0.63	0.49
	$\rho(\bar{c}, 0.1)$	0.98	0.80	0.74	0.75	0.80	0.85	0.84	0.77	0.67
	BT	0.98	0.76	0.66	0.66	0.68	0.70	0.67	0.59	0.51
	ADF	0.98	0.76	0.66	0.66	0.71	0.78	0.67	0.49	0.38
	ADF-GLS	0.98	0.81	0.75	0.76	0.79	0.84	0.83	0.74	0.62

Table 10: Finite sample rejection frequencies: Linear Trend, T = 100

Notes: The ADF and ADF-GLS tests use the MAIC to determine the lag augmentation with $k_{\min} = 0$ and $k_{\max} = \lfloor 12(T/100)^{1/4} \rfloor$ as in Perron & Qu (2007). The BT, $\rho(0.1)$, and $\rho(\bar{c}, 0.1)$ tests use the sieve bootstrap with same lag length as the ADF and ADF-GLS tests. For each statistic, entries under the rows marked $\phi = 1.00$ are the finite sample rejection frequencies under the null, i.e. the size. All other entries are finite sample power. Based on 20,000 Monte Carlo replications.

	m , , , , , , , , , , , , , , , , , , ,				0.0	0.0	0.0		0.0	0.0
ϕ	Test statistic $\setminus a$	-0.8	-0.6	-0.4	-0.2	0.0	0.2	0.4	0.6	0.8
1.00	$\rho(0.1)$	0.07	0.06	0.05	0.05	0.05	0.05	0.05	0.05	0.05
	$ ho\left(ar{c},0.1 ight)$	0.05	0.05	0.05	0.05	0.05	0.05	0.05	0.05	0.04
	BT	0.06	0.05	0.05	0.05	0.05	0.05	0.05	0.05	0.05
	ADF	0.03	0.02	0.02	0.02	0.02	0.02	0.02	0.02	0.02
	ADF-GLS	0.06	0.05	0.05	0.04	0.04	0.04	0.04	0.04	0.04
0.98	$ ho\left(0.1 ight)$	0.46	0.41	0.38	0.37	0.36	0.35	0.34	0.33	0.31
	$ ho\left(ar{c},0.1 ight)$	0.64	0.57	0.54	0.52	0.52	0.51	0.50	0.49	0.46
	BT	0.35	0.31	0.29	0.29	0.29	0.29	0.28	0.28	0.28
	ADF	0.28	0.24	0.23	0.22	0.21	0.21	0.18	0.18	0.16
	ADF-GLS	0.76	0.71	0.70	0.70	0.70	0.68	0.65	0.64	0.60
0.96	$ ho\left(0.1 ight)$	0.85	0.81	0.79	0.77	0.77	0.75	0.74	0.72	0.68
	$\rho(\bar{c}, 0.1)$	0.96	0.93	0.90	0.89	0.89	0.88	0.87	0.86	0.84
	BT	0.65	0.57	0.54	0.52	0.52	0.52	0.51	0.51	0.49
	ADF	0.70	0.66	0.67	0.69	0.70	0.66	0.62	0.58	0.51
	ADF-GLS	0.98	0.97	0.97	0.98	0.98	0.97	0.97	0.96	0.95
0.94	$ ho\left(0.1 ight)$	0.97	0.95	0.94	0.94	0.93	0.92	0.92	0.91	0.88
	$\rho(\bar{c}, 0.1)$	1.00	0.99	0.98	0.98	0.98	0.97	0.97	0.96	0.96
	BT	0.83	0.73	0.70	0.68	0.68	0.67	0.66	0.66	0.64
	ADF	0.92	0.87	0.89	0.90	0.91	0.89	0.88	0.85	0.79
	ADF-GLS	1.00	1.00	1.00	1.00	1.00	1.00	1.00	0.99	0.99
0.92	$ ho\left(0.1 ight)$	1.00	0.98	0.98	0.98	0.97	0.97	0.97	0.96	0.95
	$\rho(\bar{c}, 0.1)$	1.00	1.00	0.99	0.99	0.99	0.99	0.99	0.99	0.99
	BT	0.91	0.84	0.80	0.78	0.77	0.76	0.76	0.75	0.74
	ADF	0.98	0.95	0.95	0.95	0.96	0.95	0.95	0.94	0.91
	ADF-GLS	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00

Table 11: Finite sample rejection frequencies: Constant Mean, T = 500

Notes: The ADF and ADF-GLS tests use the MAIC to determine the lag augmentation with $k_{\min} = 0$ and $k_{\max} = \lfloor 12(T/100)^{1/4} \rfloor$ as in Perron & Qu (2007). The BT, $\rho(0.1)$, and $\rho(\bar{c}, 0.1)$ tests use the sieve bootstrap with same lag length as the ADF and ADF-GLS tests. For each statistic, entries under the rows marked $\phi = 1.00$ are the finite sample rejection frequencies under the null, i.e. the size. All other entries are finite sample power. Based on 20,000 Monte Carlo replications.

ϕ	Test statistic $\setminus a$	-0.8	-0.6	-0.4	-0.2	0.0	0.2	0.4	0.6	0.8
1.00	$ ho\left(0.1 ight)$	0.07	0.05	0.05	0.05	0.05	0.05	0.05	0.04	0.04
	$ ho\left(ar{c},0.1 ight)$	0.06	0.06	0.06	0.06	0.06	0.06	0.06	0.06	0.06
	BT	0.06	0.05	0.05	0.05	0.05	0.05	0.05	0.05	0.05
	ADF	0.05	0.03	0.03	0.03	0.02	0.02	0.02	0.02	0.02
	ADF-GLS	0.05	0.05	0.04	0.04	0.03	0.04	0.03	0.03	0.03
0.98	$ ho\left(0.1 ight)$	0.22	0.20	0.20	0.19	0.19	0.19	0.18	0.17	0.14
	$ ho\left(ar{c},0.1 ight)$	0.29	0.29	0.30	0.30	0.30	0.30	0.29	0.27	0.24
	BT	0.21	0.19	0.18	0.18	0.18	0.18	0.17	0.17	0.16
	ADF	0.18	0.15	0.13	0.13	0.12	0.12	0.10	0.10	0.08
	ADF-GLS	0.28	0.25	0.24	0.23	0.22	0.21	0.19	0.18	0.16
0.96	$ ho\left(0.1 ight)$	0.54	0.52	0.53	0.53	0.53	0.51	0.49	0.45	0.39
	$ ho\left(ar{c},0.1 ight)$	0.71	0.70	0.71	0.71	0.72	0.70	0.68	0.65	0.59
	BT	0.48	0.42	0.41	0.40	0.40	0.39	0.39	0.38	0.35
	ADF	0.49	0.44	0.45	0.46	0.46	0.43	0.38	0.35	0.29
	ADF-GLS	0.71	0.67	0.67	0.70	0.71	0.68	0.64	0.59	0.52
0.94	$ ho\left(0.1 ight)$	0.79	0.76	0.78	0.79	0.80	0.77	0.76	0.72	0.64
	$ ho\left(ar{c},0.1 ight)$	0.91	0.88	0.90	0.90	0.91	0.89	0.89	0.86	0.82
	BT	0.70	0.64	0.61	0.60	0.60	0.59	0.58	0.56	0.53
	ADF	0.77	0.71	0.74	0.76	0.79	0.74	0.71	0.65	0.56
	ADF-GLS	0.91	0.88	0.90	0.91	0.92	0.90	0.89	0.86	0.80
0.92	$ ho\left(0.1 ight)$	0.92	0.87	0.89	0.90	0.91	0.89	0.88	0.86	0.80
	$\rho(\bar{c}, 0.1)$	0.97	0.95	0.95	0.95	0.96	0.95	0.95	0.94	0.91
	BT	0.84	0.77	0.75	0.74	0.73	0.72	0.71	0.69	0.66
	ADF	0.92	0.84	0.86	0.88	0.90	0.88	0.87	0.83	0.75
	ADF-GLS	0.98	0.95	0.95	0.96	0.96	0.96	0.95	0.94	0.91

Table 12: Finite sample rejection frequencies: Linear Trend, T = 500

Notes: The ADF and ADF-GLS tests use the MAIC to determine the lag augmentation with $k_{\min} = 0$ and $k_{\max} = \lfloor 12(T/100)^{1/4} \rfloor$ as in Perron & Qu (2007). The BT, $\rho(0.1)$, and $\rho(\bar{c}, 0.1)$ tests use the sieve bootstrap with same lag length as the ADF and ADF-GLS tests. For each statistic, entries under the rows marked $\phi = 1.00$ are the finite sample rejection frequencies under the null, i.e. the size. All other entries are finite sample power. Based on 20,000 Monte Carlo replications.

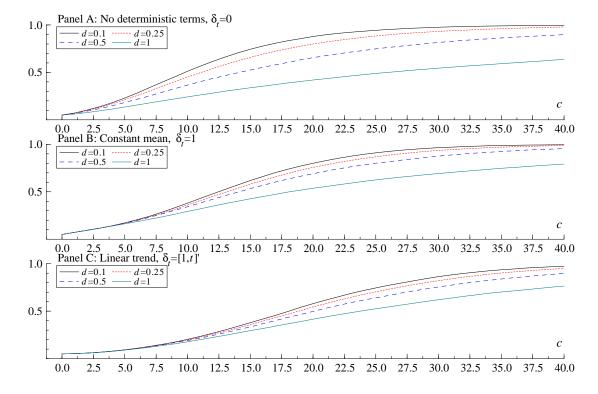


Figure 1: Asymptotic local power functions of $\rho(d)$ against near-integrated alternatives

Figure 2: Asymptotic local power functions of GLS detrended tests against near-integrated alternatives

